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15 GHz COOLED GaAsFET AMPLIFIER –
DESIGN BACKGROUND INFORMATION

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15 GHz COOLED GaAsFET AMPLIFIER —
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Manuel Sierra

I. Noise Parameters of FET's

Measurement and Analysis Procedure

In order to obtain the noise parameters of FET's used in a 3-stage amplifier a one stage amplifier has been constructed and the noise measured for a set of five source impedances and five values for the bias current.

The input and output networks have been made with a $\lambda/4$ sliding transformer over a 50 ohm transmission line, as shown in Figure 1. With this mount, it is easy to change the source impedance by changing the diameter of the $\lambda/4$ transformer or the dielectric surrounding it, which changes the absolute value of the reflection coefficient, or by moving this transformer along the 50 ohm line, which changes the phase. Nevertheless, for the noise parameter measurements, the transformer position has been selected to get a minimum noise at the design frequency (14.9 GHz) for each transformer impedance.

Usually, the amplifier input is tuned for minimum noise at only one bias and at room temperature, and some frequency variations in the minimum noise can be expected. Taking this minimum, that must happen not too far from the design frequency, it is assumed that at that point the source reactance is optimum ($X_S = X_{Opt}$), and the noise parameters not too far from those at the design frequency. When three or more source impedances have been tried, it is possible to determine the three noise parameters by adjusting the theoretical parabolic

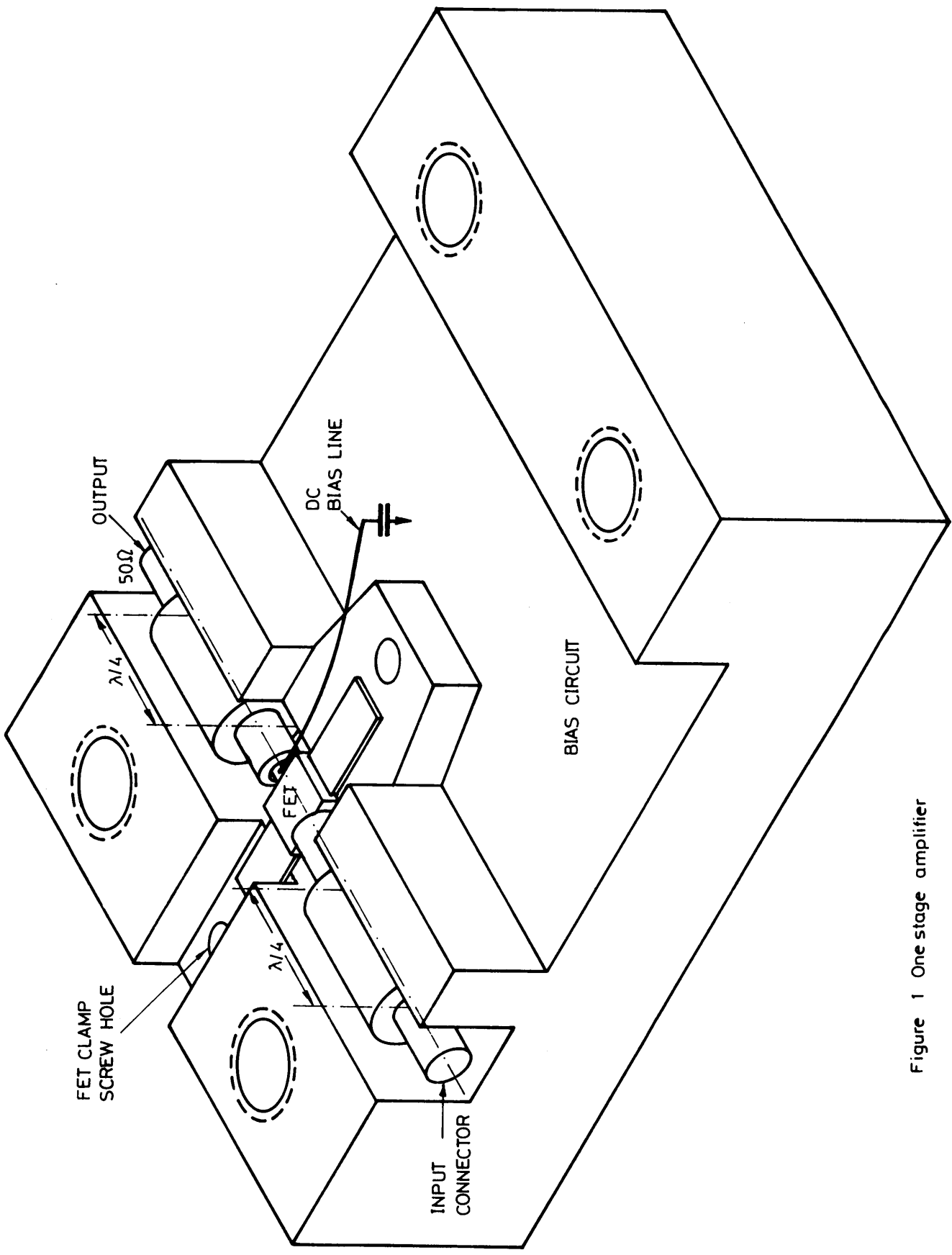


Figure 1 One stage amplifier

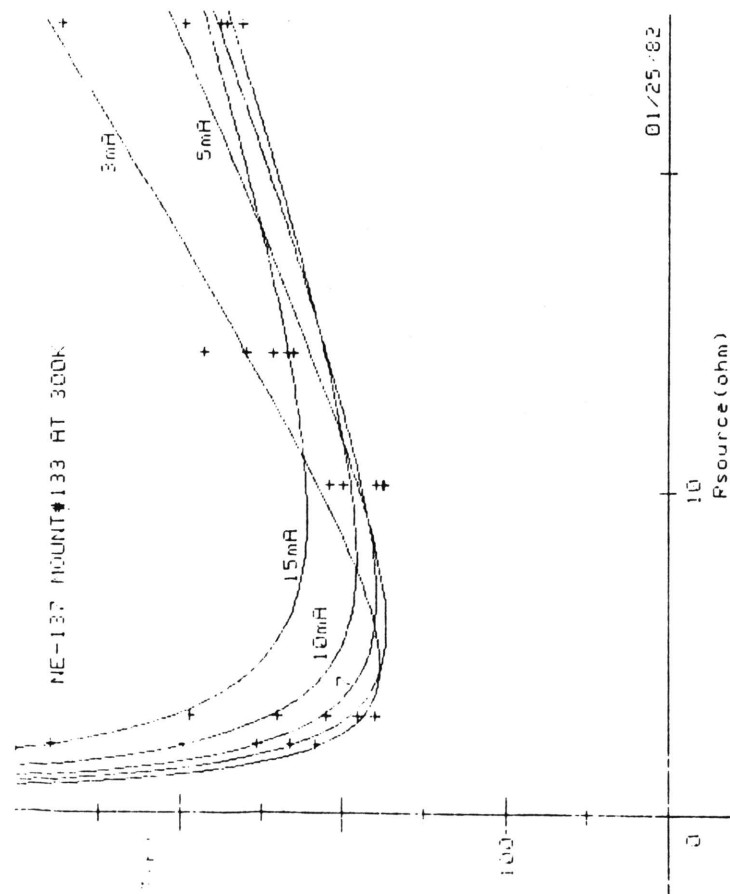
function. This has been done with the aid of the computer program "Ropt 1" discussed in Appendix 1. The program adjusts the values of R_{opt} , T_{min} and G_n for the least quadratic error method and presents the final values as well as the mean square error on temperature.

For all these measurements, the output network is matched for maximum return loss; this allows high gain and, hence, lower errors in the second stage noise cancellation.

Noise Parameters for NE-137 and MGF-1412

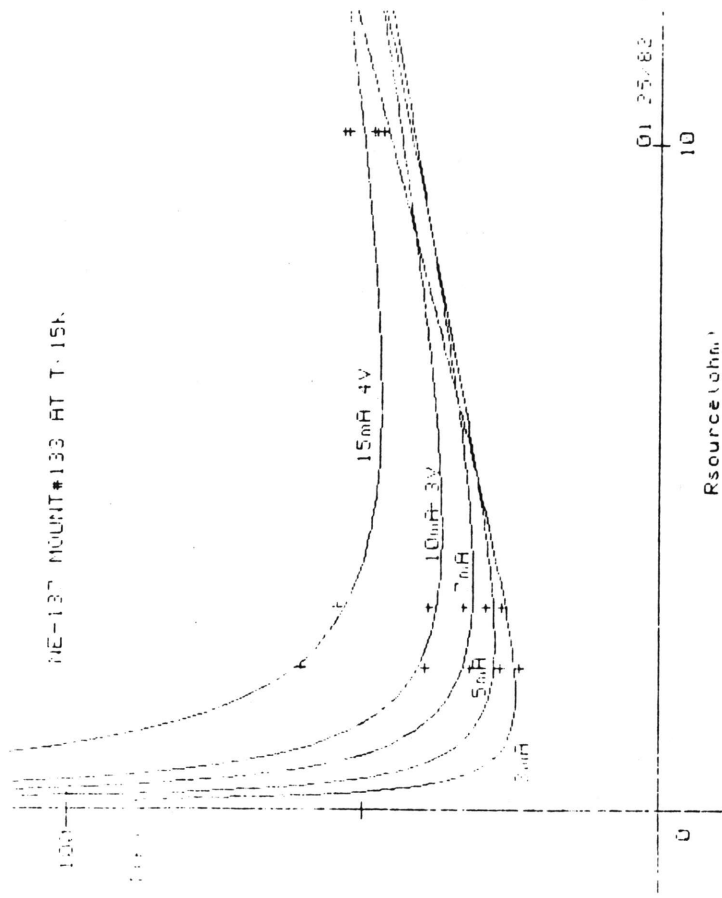
Measuring the NE-137 FET, five transformers have been used, with 10, 12, 22, 26 and 36 ohm characteristic impedance. We also took the noise corresponding to five different bias currents, from 3 to 15 mA and the drain voltage that leads to a minimum noise at each current. For the NE-137, the drain voltage does not affect the noise, at least between 2.5 and 5 volts, and the small variations for low current have a minimum noise around 3 or 4 volts. It is important to note that the output match is more affected by the drain voltage, and that also affects the second stage noise. This means that the optimum voltage in noise measurements usually remains the same as the one selected for the output tuning.

The final results for the packaged NE-137 at 15K and room temperature are shown in Figure 2, where the noise temperature is plotted versus the source resistance, using the drain current as a parameter. It can be seen that at room temperature, the optimum current is around 5 mA and $R_{opt} \simeq 4$ ohms. At 15K the optimum current drops to values under 3 mA and the optimum source resistance to under 2 ohms, but taking into account that the gain also drops very fast for low currents, the optimum noise measure occurs around 3 mA.



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| Bias | Rsource (ohm) | | | | |
|------------------------|---------------|-----------|----------|----------|----------|
| | 15 mA, 3V | 10 mA, 3V | 7 mA, 3V | 5 mA, 3V | 3 mA, 3V |
| T _{min} (K) | 221.7 | 191.1 | 179.1 | 172.8 | 176.7 |
| R _{opt} (ohm) | 9.18 | 7.84 | 6.65 | 5.74 | 4.58 |
| G _n (mmhos) | 22.3 | 23.4 | 25.9 | 31.5 | 43.2 |
| Mean square error (K) | 14.4 | 12.9 | 11.3 | 13.0 | 14.7 |



01/25/82

| Bias | Rsource (ohm) | | | | |
|------------------------|---------------|-----------|----------|----------|----------|
| | 15 mA, 4V | 10 mA, 3V | 7 mA, 3V | 5 mA, 3V | 3 mA, 3V |
| T _{min} | 46.9 | 36.5 | 31.4 | 27.7 | 24.2 |
| R _{opt} | 6.05 | 4.18 | 3.42 | 2.52 | 1.73 |
| G _n (mmhos) | 6.91 | 7.15 | 7.89 | 8.64 | 10.67 |
| Mean square error (K) | 2.91 | 3.90 | 4.53 | 4.84 | 5.40 |

Fig. 2. Noise temperature at 300K (left) and 15K (right) for NE13783 as function of generator resistance and drain current. The table gives the noise parameters determined from the figure.

The drain voltage has little effect upon the noise, and usually is selected in order to have the best output match or to optimize the second stage noise when using more than a one-stage amplifier.

From the MGF-1412 measurements, the same temperature dependence can be seen in the noise parameters and in the optimum bias current. The most important difference between this and the NE-137 is the greater drain voltage dependence of the MGF-1412 noise; an optimum voltage can be clearly found for each drain current. Usually the optimum voltage increases as the current increases, keeping the gate voltage fairly constant except for very low currents.

It looks like the noise parameters of the MGF-1412's are related to both drain current and gate voltage through two independent functions, at least in the most important range of bias.

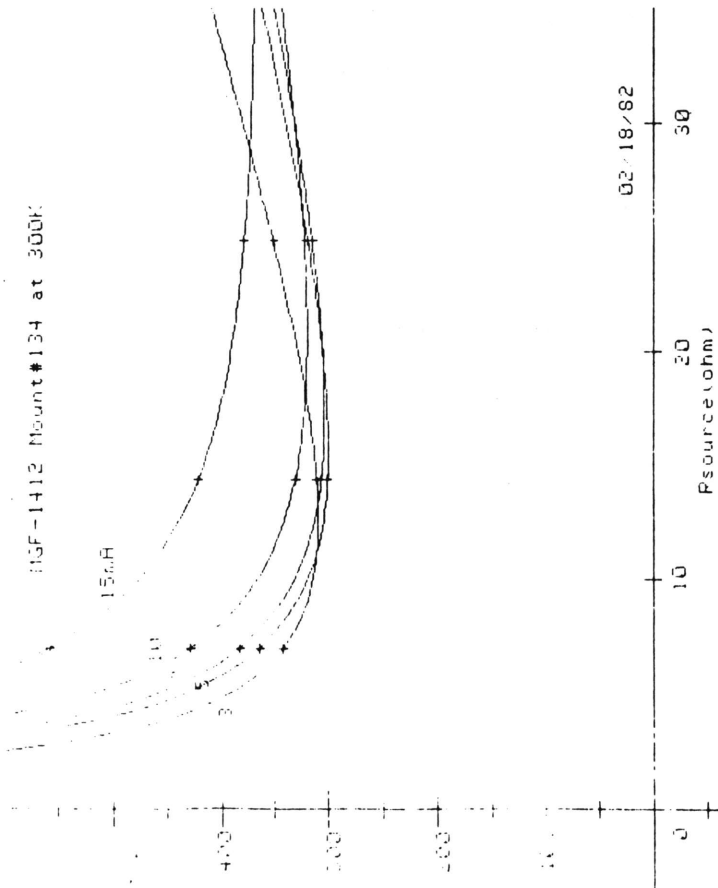
The optimum source reactance has been estimated from circuit modeling and assumed constant; the frequency where the minimum noise appears changes only a small amount when the bias or physical temperatures are changed.

The MGF-1412 measurements are shown in Figure 3 with values at 15K and room temperature.

In Appendix 2 are presented the circuit and noise parameter models used in the computer programs for these two FET's. The frequency variation of the noise parameters has also been estimated from the frequency behavior of chip noise predicted by Pucel.

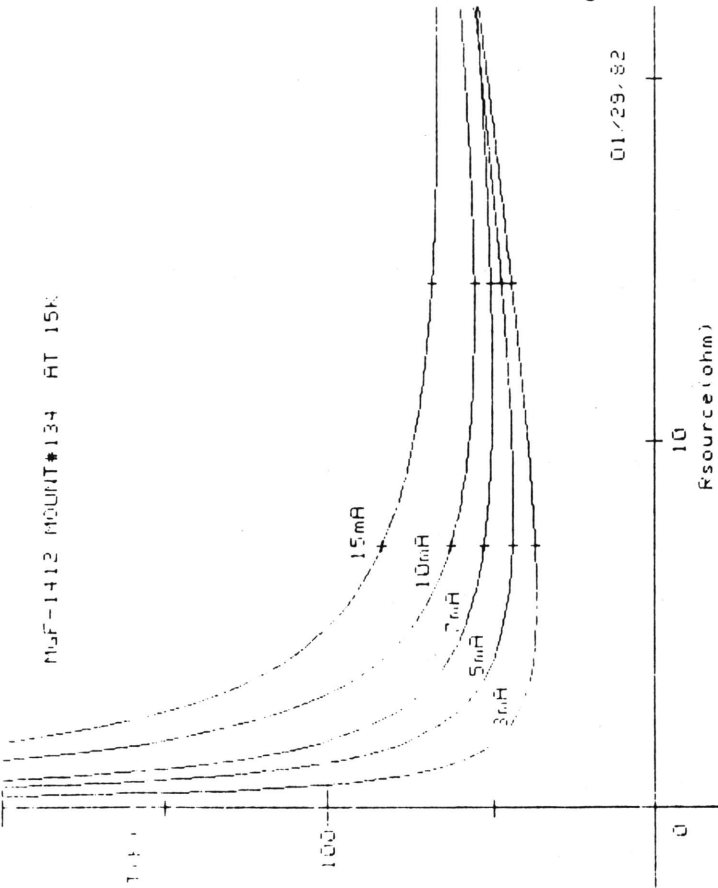
Errors in the Noise Measurements

Due to the low gain of these transistors at 15 GHz, large errors can be expected in one-stage amplifier measurements if all additional noise contributions are not taken into account.



| Bias | 15 mA, 5.5V | 10 mA, 5.5V | 7 mA, 5V | 5 mA, 4V | 3 mA, 3.5V |
|-----------------|-------------|-------------|----------|----------|------------|
| T_{min} (K) | 367.3 | 318.5 | 302.7 | 299.2 | 308.5 |
| R_{opt} (ohm) | 38.0 | 20.8 | 17.4 | 15.8 | 12.7 |
| ζ_n | 4.78 | 13.7 | 17.6 | 19.8 | 24.1 |

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| Bias | 15 mA, 5.5V | 10 mA, 5V | 7 mA, 4V | 5 mA, 4V | 3 mA, 3.5V |
|-----------|-------------|-----------|----------|----------|------------|
| T_{min} | 67.2 | 55.7 | 50.2 | 43.8 | 36.7 |
| R_{opt} | 19.6 | 13.4 | 11.5 | 8.3 | 5.7 |
| ζ_n | 2.59 | 4.47 | 3.35 | 4.83 | 5.10 |

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MGF-1412 Mount#134 RT 15K

MGF-1412 Mount#134 at 300K

Fig. 3. Noise temperature at 300K (left) and 15K (right) for MGF-1412 as function of generator resistance and drain current. The table gives the noise parameters determined from the figure.

We are going to analyze here only the errors due to the noise source calibration and the second-stage noise cancellation, assuming that the rest has little influence in the final error.

In order to avoid changes in the noise source impedance when switching, and also to get a lower off temperature, a 20 dB cooled pad is used following the noise source. The total losses from the noise source to the amplifier input have been measured and the equivalent off and on temperatures are computed.

Assuming that the noise diode calibration has no errors, the error due to the pad attenuation can be computed as follows:

$$\frac{\Delta T}{\Delta \alpha} \approx .25 (T + T_{\text{off}}) \text{ K/dB} \quad (1)$$

where T is the measured temperature and $\Delta \alpha$ is the attenuation error in dB (<1). T_{off} is the equivalent off temperature.

Another noise contribution came from the receiver or second stage. This additional noise is taken into account measuring the second stage noise and computing its contribution to the total noise. In fact, measuring first the equivalent noise and gain of the receiver (T_R , G_R) and then the total noise and gain (T_T , G_T), the receiver noise contribution is done by

$$T_e = \frac{T_R}{G_{\text{av}}} = T_R \cdot \frac{G_R}{G_T} \quad (2)$$

where G_{av} is the available gain of the amplifier. In equation (2), it is assumed that the receiver performance (noise and gain) remains the same when driven by the noise source and when driven by the amplifier.

The difference between the reflection coefficient of the noise source and the amplifier output causes an error in the receiver performance. Let us assume, as shown in Figure 4, that the receiver is driven by a circulator with input reflection coefficient Γ_R and physical temperature T_C . The error in the receiver noise contribution can be written as follows (see Appendix 3):

$$\Delta T = \frac{T_C(|\Gamma_2|^2 - |\Gamma_S|^2)}{G_m} \cdot \left| \frac{1 - \Gamma_S \Gamma_R}{1 - \Gamma_2 \Gamma_R} \right|^2 - \frac{T_R}{G_m} \left(1 - \left| \frac{1 - \Gamma_S \Gamma_R}{1 - \Gamma_2 \Gamma_R} \right|^2 \right)$$

where G_m is the measured gain $G_m = G_T/G_R$ and the reflection coefficients are defined as shown in Figure 4.

The noise source is usually well matched and then the first term is positive and is the noise generated in the circulator load and reflected in the amplifier output. The second term depends on the relative phases of the reflection coefficient and can be either positive or negative. The extreme values for this error when $\Gamma_S \approx 0$ can be written as follows:

$$\Delta T_{\max} \approx \frac{T_C |\Gamma_2|^2 + T_R (2 |\Gamma_2 \Gamma_R|)}{G_m (1 + |\Gamma_2 \Gamma_R|)^2}$$

$$\Delta T_{\min} \approx \frac{T_C |\Gamma_2|^2 - T_R (2 |\Gamma_2 \Gamma_R|)}{G_m (1 + |\Gamma_2 \Gamma_R|)^2}$$

In order to minimize these errors, the amplifier output has been matched at least with 15 dB return loss and a cooled circulator as well as the receiver input circulator have been used.

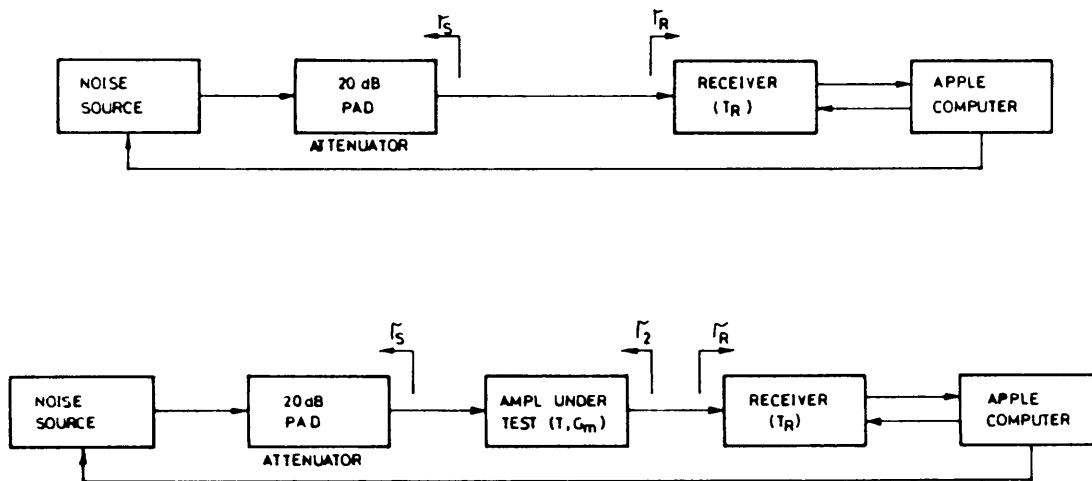


Fig. 4. Test set for computer measurement of amplifier gain and noise temperature. Top configuration is for "CAL" mode which determines receiver gain and noise temperature; lower configuration is for "TEST" mode which determines amplifier gain and noise temperature.

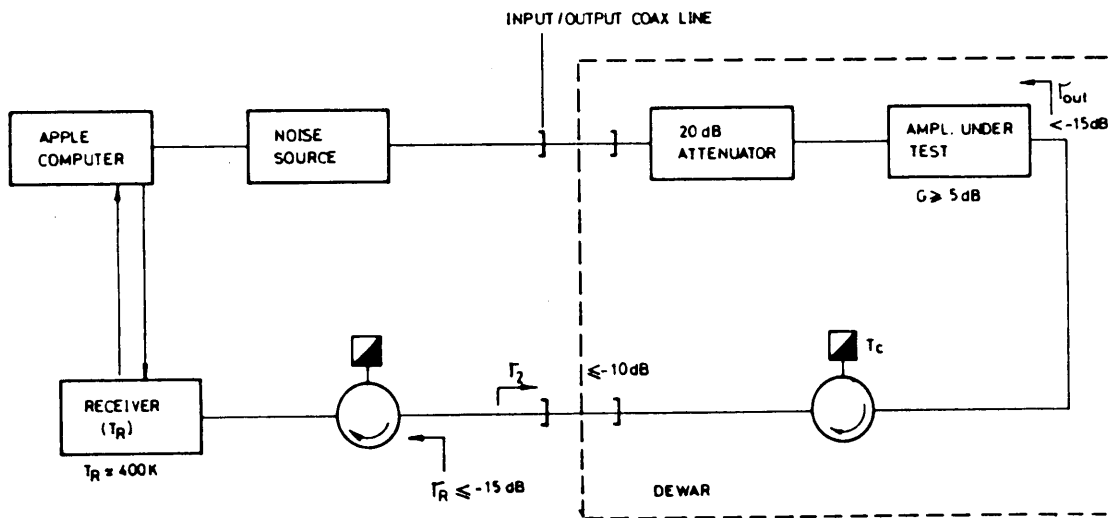


Fig. 5. Test setup for measurement of cryogenically cooled amplifier.

The final mount for cooled measurements is shown in Figure 5 where most parameters are specified. The final error limits are listed in Table 1.

TABLE I. Measurement Errors

| <u>Physical Temperature</u> | <u>300K</u> | | <u>15K</u> | |
|-----------------------------|-----------------|-----------|---------------|-----------|
| Noise source NDB | -5.58 \pm .05 | | 5.56 \pm .1 | |
| Noise source error | \leq 10K | | \leq 2.4K | |
| Amplifier gain | > 4dB | > 7dB | > 5dB | > 8dB |
| Cooled isolator noise | + 3.8 | + 1.9 | + .15 | + .06 |
| Second isolator noise | | | + 3.8 | + 9.5 |
| Second stage noise error | \pm 10.2 | \pm 5.1 | \pm 14.6 | \pm 5.8 |

Package and Chip Noise Parameters

Having a model for the FET package, it is possible to compute the chip noise parameters and see how they agree with the theoretical predictions or other frequency measurements.

The package model has been computed for the MGF-1412 from S parameters and low frequency package measurements as discussed in [1]. The NE-137 package model has been computed from the chip and packaged FET S-parameters.

The models are shown in Appendix 2. The chip noise parameters for the NE-137 and MGF-1412 are also shown in Table II. Two bias currents are used to compute these parameters, the recommended and the minimum noise current, both at 15K and at room temperature.

TABLE II. Chip Noise Parameters

| <u>NE-137</u> | <u>300K</u> | | <u>15K</u> | |
|---------------|-------------|----------|------------|----------|
| | Bias | | | |
| Bias | 10 mA, 3V | 5 mA, 3V | 10 mA, 3V | 3 mA, 3V |
| T_{min} | 182 | 164 | 34.1 | 21.3 |
| R_{opt} | 6.6 | 4.9 | 3.4 | 1.23 |
| X_{opt} | 27.3 | 27.6 | 27.4 | 27.5 |
| G_n (mmhos) | 26.5 | 35.7 | 8.2 | 12.1 |

| <u>MGF-1412</u> | <u>300K</u> | | <u>15K</u> | |
|-----------------|--------------|----------|------------|------------|
| | Bias | | | |
| Bias | 10 mA, 5.5 V | 5 mA, 4V | 10 mA, 5V | 3 mA, 3.5V |
| T_{min} | 289 | 267 | 49.2 | 28.3 |
| R_{opt} | 12.5 | 10.8 | 8.7 | 3.5 |
| X_{opt} | 16.3 | 19.2 | 18.9 | 22.3 |
| G_n (mmhos) | 20.8 | 26.4 | 6.3 | 6.2 |

From the chip noise parameters and assuming the theoretical frequency variation, it is possible to compute the noise parameter frequency dependence of the packaged FET. This has been done in Figures 6-13 for both transistors at room temperature and cooled. It is interesting to note that noise parameters of the packaged transistors are much different from those of the chip at high frequencies. The noise temperature is not affected by the package input circuit but is affected by the source inductance in such a way that the noise measure remains constant.

Looking at these figures, it is reasonable that it is not possible to compare the noise parameters at different frequencies if the mount or surrounding

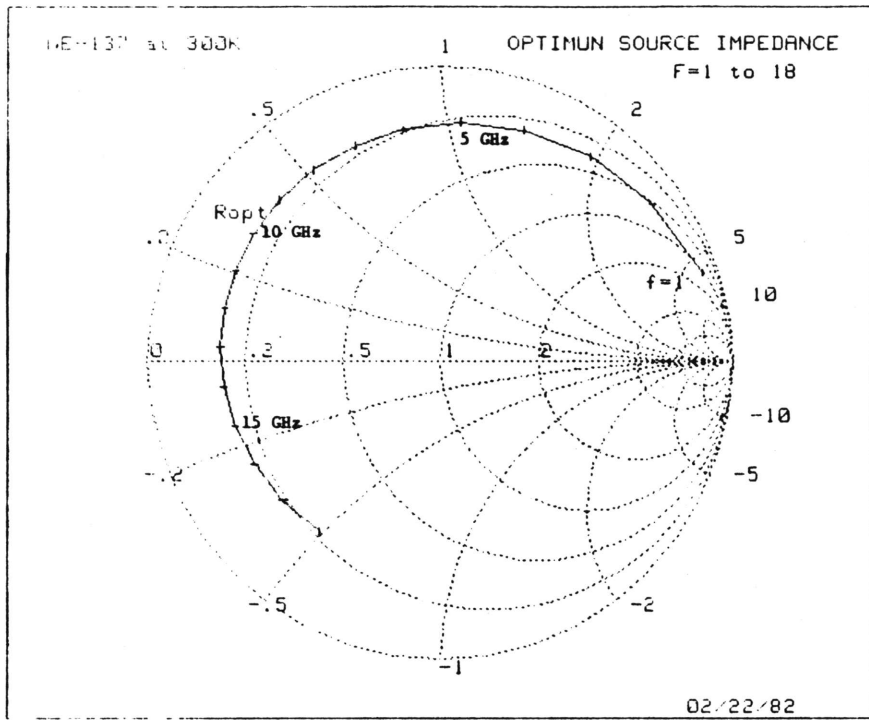


Fig. 6. Optimum source impedance at 300K for the NE137 in steps of 1 GHz from 1 to 18 GHz.

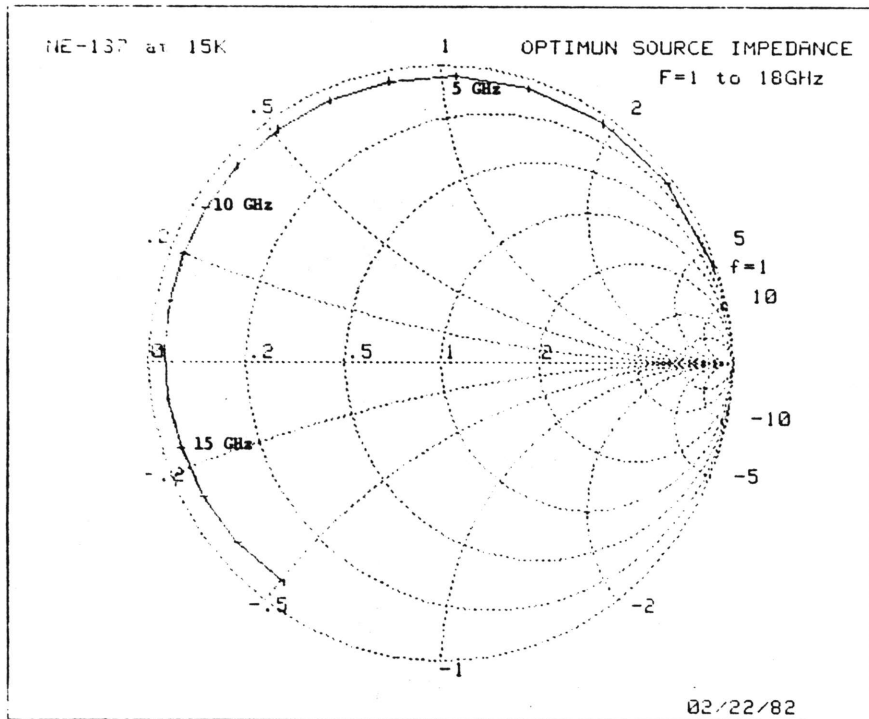


Fig. 8. Optimum source impedance at 15K for the NE137 in steps of 1 GHz from 1 to 18 GHz.

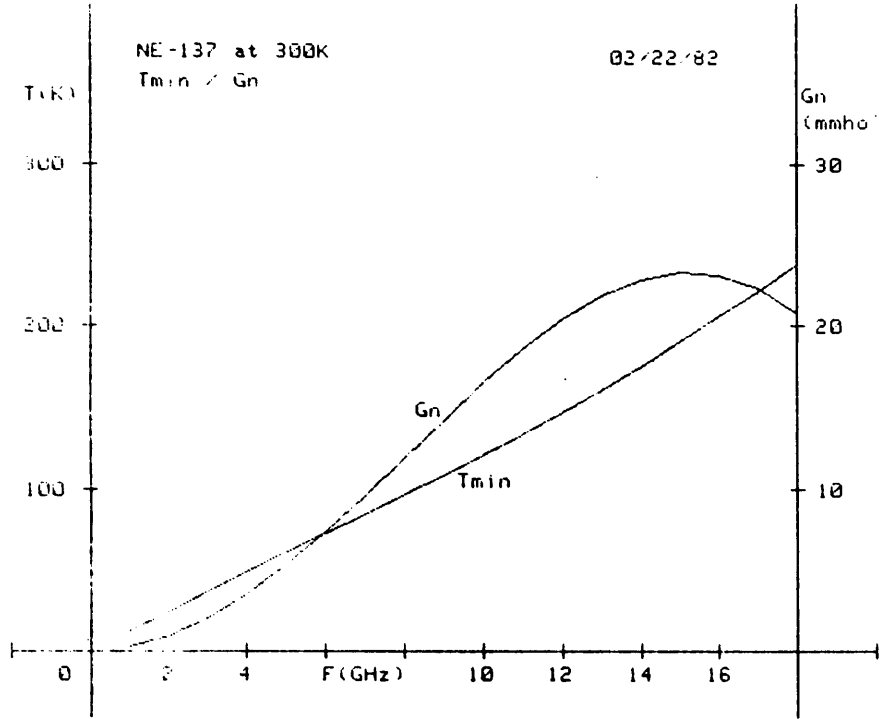


Fig. 7. Noise parameters, T_{min} and g_n , for the NE137 at 300K in the 1 to 18 GHz frequency range.

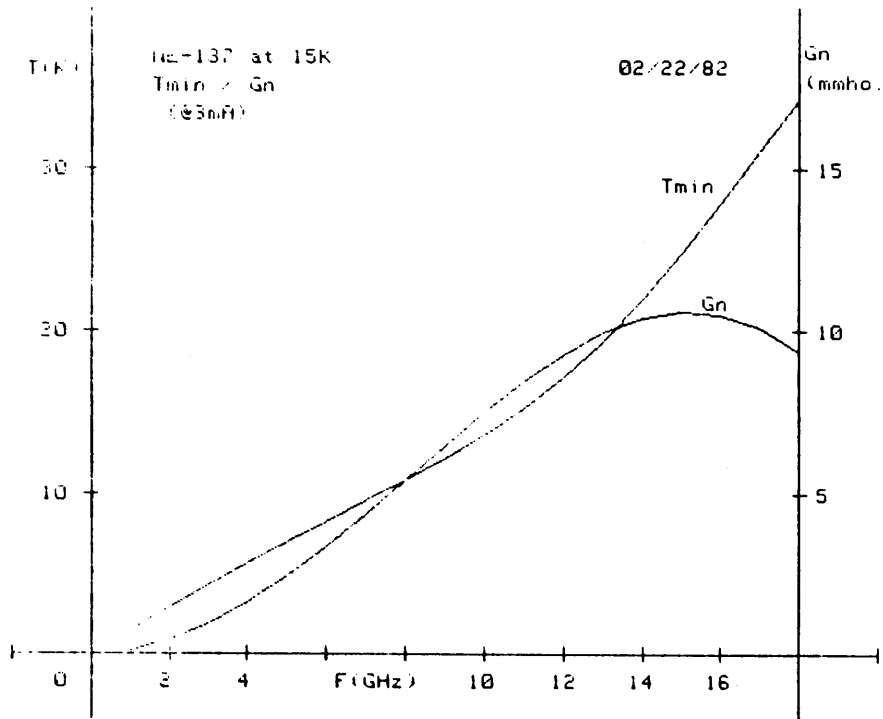


Fig. 9. Noise parameters, T_{min} and g_n , for the NE137 at 15K in the 1 to 18 GHz frequency range.

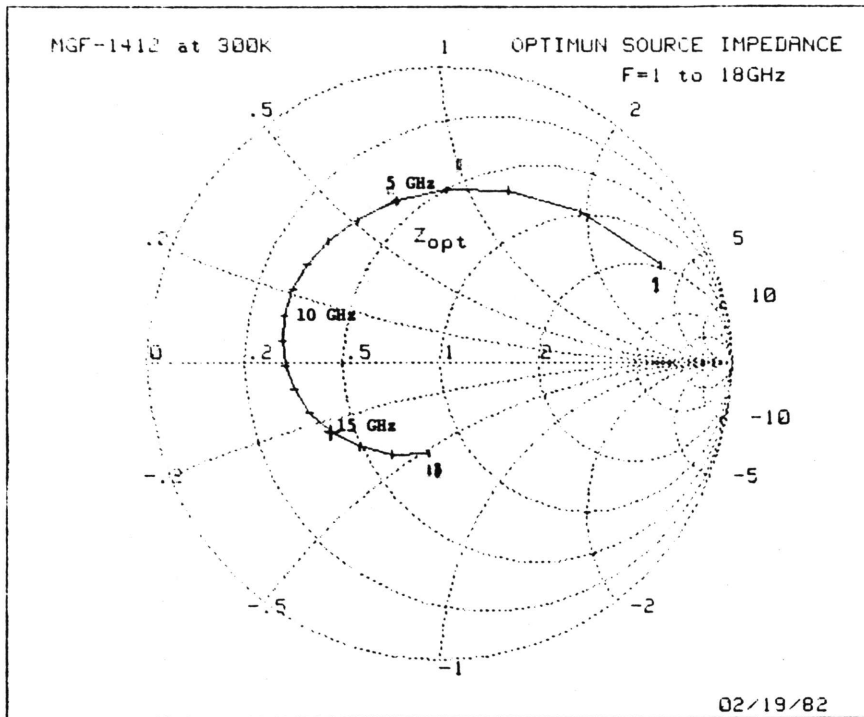


Fig. 10. Optimum source impedance at 300K for the MGF-1412 in steps of 1 GHz from 1 to 18 GHz.

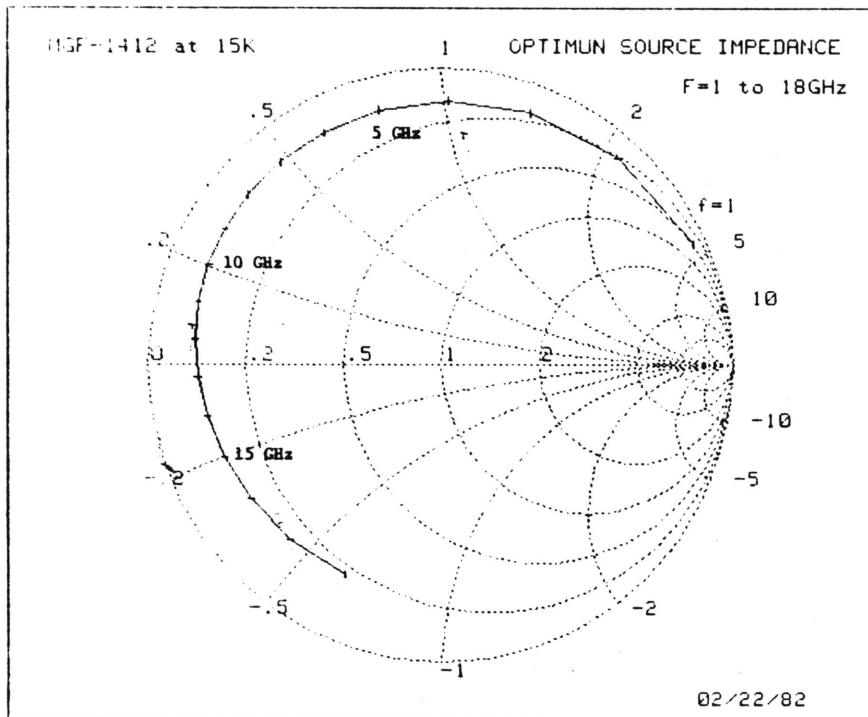
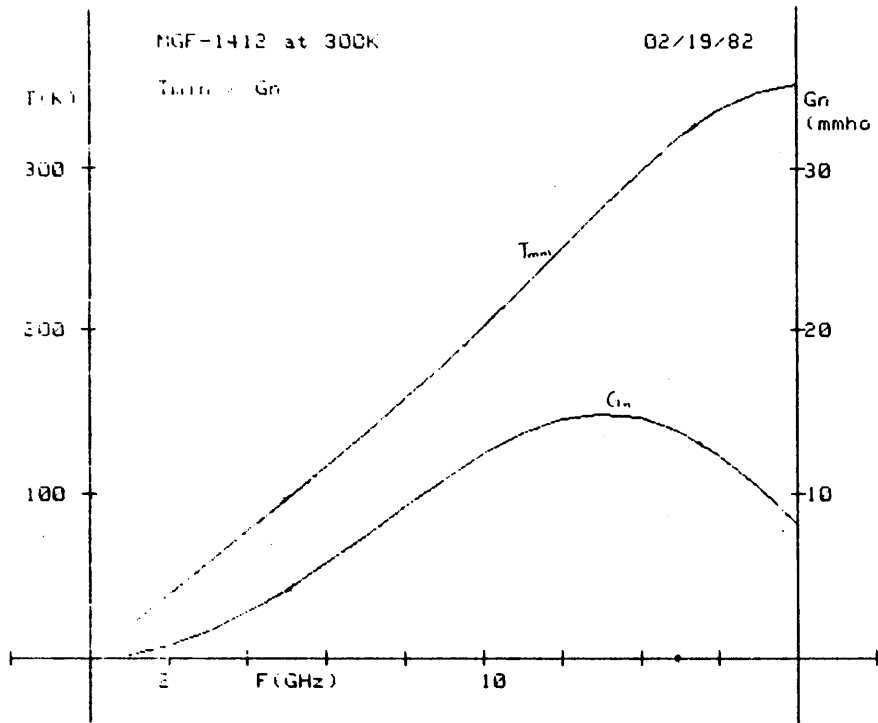
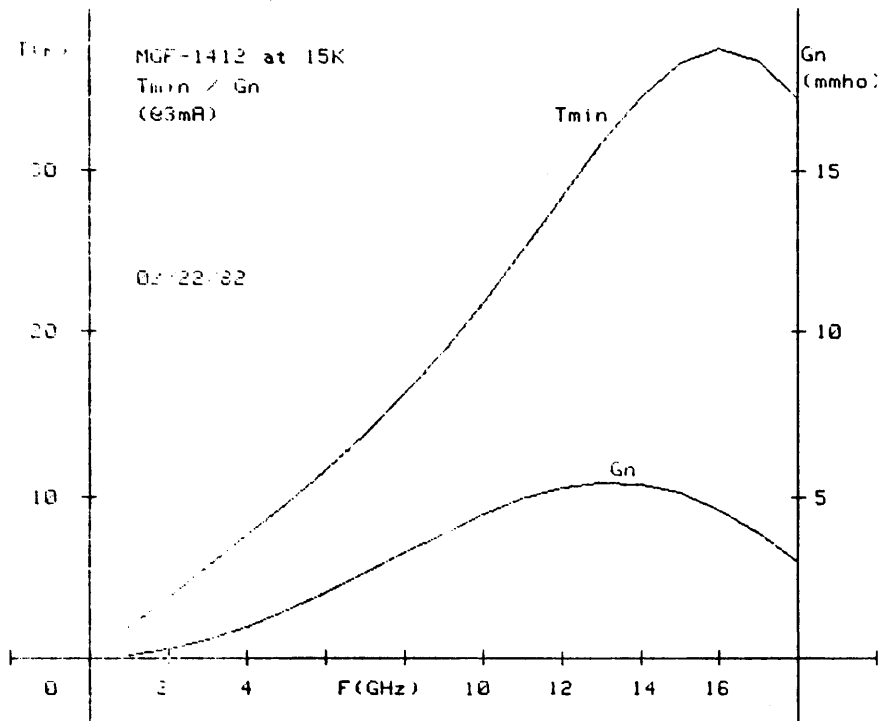


Fig. 12. Optimum source impedance at 15K for MGF-1412 in steps of 1 GHz from 1 to 18 GHz.



11. Noise parameters, T_{min} and g_n , at 300K for the MGF-141 in the 1 to 18 GHz frequency range.



13. Noise parameters, T_{min} and g_n , for the MGF-1412 at 15K in the 1 to 18 GHz frequency range.

circuit where the transistor has been measured are not the same. The only parameter that can be estimated is the noise measure that does not change with any reactive feedback.

II. Amplifier Design

Technology

The final amplifier has been realized with the same technology as the one-stage test mount previously described. The main transmission line is a coaxial line formed by the square outer conductor machined as a groove in the chassis, and a circular inner conductor supported by a .05 inch thick polystyrene support to prevent movement along the line [2].

The input and output network used for each stage is formed by a $\lambda/4$ transmission line with a lower than 50Ω characteristic impedance in cascade with a 50Ω transmission line. With this coupling network, it is always possible to get any desired impedance.

The D.C. blocking capacitors are formed by inserting the FET leads into the coaxial inner conductor lined with #22-PTFE teflon tubing. This forms a series transmission line that has around 38 ohm characteristic impedance and 1.8 effective dielectric constant. The open-circuited end has around .04 pF fringing capacitance.

Although it is possible to match any desired impedance with the described network, the frequency response depends on the selected circuit, getting a narrower bandwidth as the 50 ohm transmission line becomes longer. In order to have the proper distance between the slug and the FET ($L \leq \lambda/16$), the series transmission line length has been adjusted. At 15 GHz the optimum generator reactance becomes capacitive because of the package inductive effects, and it is necessary to use shorter than $\lambda/4$ series lines as D.C. blocking.

D.C. bias is applied to the FET by $\lambda/4$ wires from the chip bypass capacitors and a proper D.C. protecting circuit is used, as shown in Figure 14.

Design

A 14.4 to 15.4 GHz low-noise amplifier was required as a first stage for the front ends of the Very Large Array radio telescope. The unit must be optimized for minimum noise and have 20 dB gain with no more than 2 dB ripple over the band. An input match is not required since the input will be connected through a circulator.

From these specifications and previous one-stage measurements, it can be seen that at least three stages are required. The first and second stages are driven for minimum noise and the third one can be matched either for minimum noise or maximum gain depending on the final gain.

The first stage input network is then selected to have a minimum noise (Z_{opt}), and from the transistor parameters, it is possible to know the output impedance (Z_{out}). In order to have the optimum source impedance for the second stage, the inter-stage network must transform the first stage output impedance (Z_{out}) to Z_{opt} . This condition provides two equations for computing the network, leaving one of the three parameters free (lossless network).

Going from Z_{out} to 50Ω and then to Z_{opt} as shown in Figure 14, the third parameter is easily identified with the 50-ohm transmission line length. This length can be selected in order to adjust the frequency performance or minimize the input reflection.

This solution is not the only one, of course. Any other solution can be good, but this one has the advantage that all parameters can be selected from one-stage measurements, and it is easy to mount and adjust.

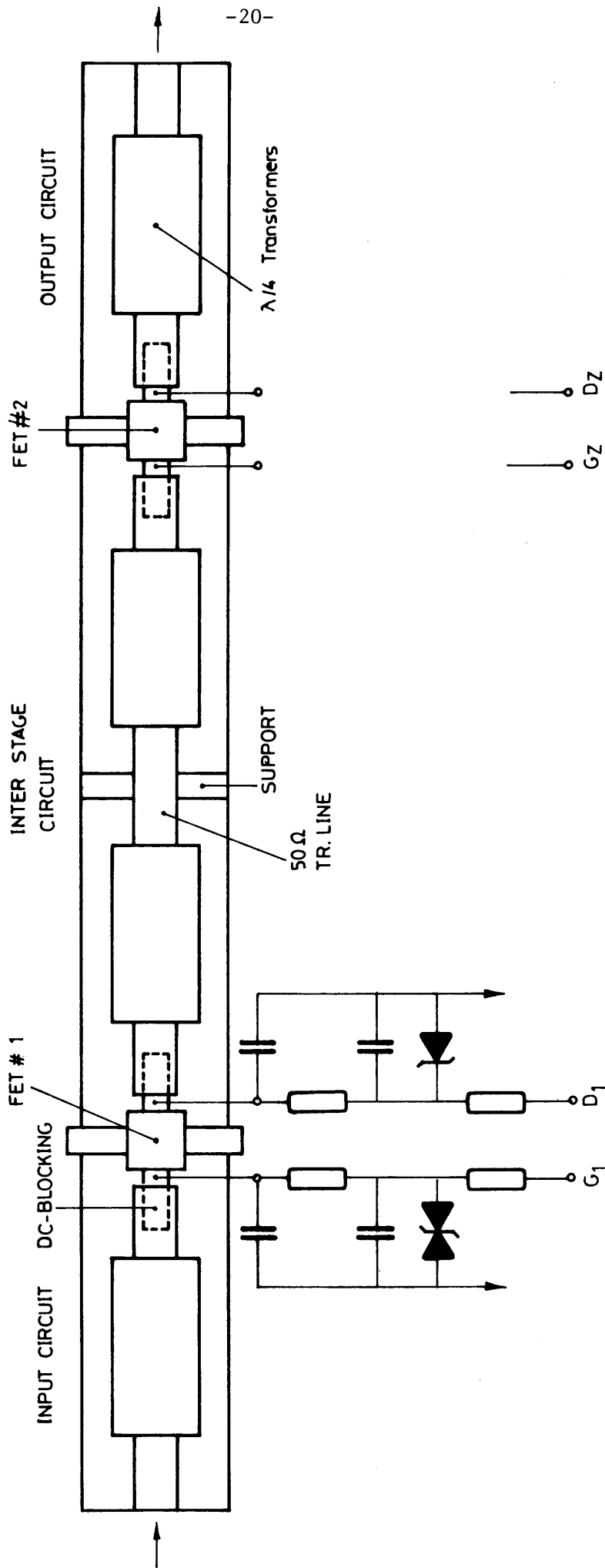


Fig. 14. Inter-stage circuit.

In order to determine the length between transformers for maximum bandwidth and have a theoretical model for the amplifier performances, some computer programs have been developed, based on the transistor models and using FARANT subroutines [3].

At first two programs were developed to compute the optimum transformer impedance and inter-stage distances. The first one (Man #4) computes the inter-stage circuit to get a maximum input return loss at the design frequency. This condition also assures the maximum amplifier gain at the design frequency. It then computes the frequency response for a two-stage amplifier. Having a bad input match or at least not enough match to avoid isolators, we would rather select this third parameter to achieve the maximum bandwidth, doing this with a cut-and-try method aided by the Amp #1 program.

Finally, an analysis program was developed to allow final adjustment of the computer model before or at the same time as the experimental amplifier (Amp #2).

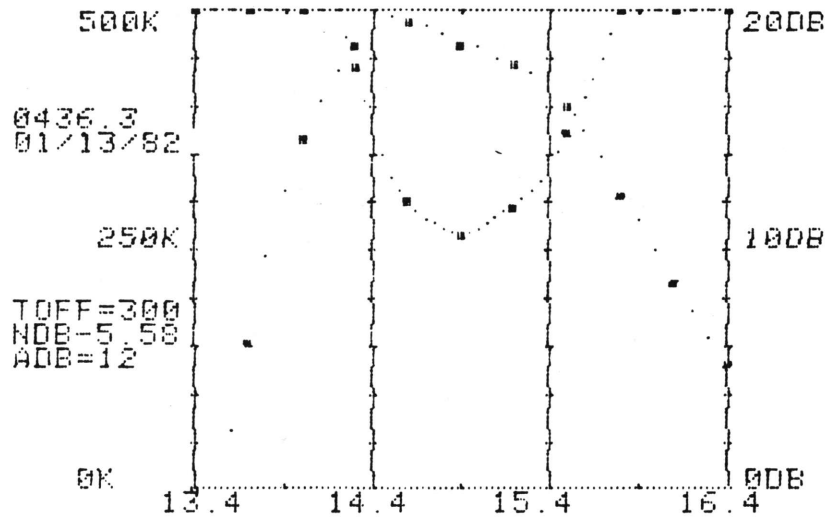
The last two programs work with one, two or three stage amplifiers as desired. The programs are listed in Appendix 3.

Experimental Results

The three stage amplifier using the NE-137 as first stage and two MGF-1412's as second and third stages was built and optimized for minimum noise and flat gain in the band. The noise temperature and gain are shown in Figure 15 for both 300K and 15K operation. The optimum temperature around the design frequency is 40K and has an average temperature of 49K over a 1 GHz bandwidth. The gain is over 24 dB which allows a 4 dB output attenuator to match the amplifier to the following stage.

The amplifier is stable for any input and output load, but an isolator is necessary to improve the input match.

1) #112 WITH 15 OHM. INPUT TR.
0436.3 01/13/82 TAU=299.8 TLO=263.3 @ 14900 GL=16.7 GH=19.7 T=296.
4.98,5.2,-1.224 4.02,14.8,-.543 3.98,14.6,-1.239



1) #112 WITH 15 OHM. INPUT TR.
0659.7 01/13/82 TAU=65.8 TLO=55.2 @ 14800 GL=22.2 GH=24.3 T=10.9K
4.98,5.2,-1.923 4.02,14.9,-.463 4.01,14.6,-1.405

2) OPTIMUM BIAS
0709.7 01/13/82 TAU=48.6 TLO=40.6 @ 14800 GL=23.7 GH=25.7 T=11K
3.97,5.1,-1.745 5.51,14.8,-.58 5.5,19.5,-1.4

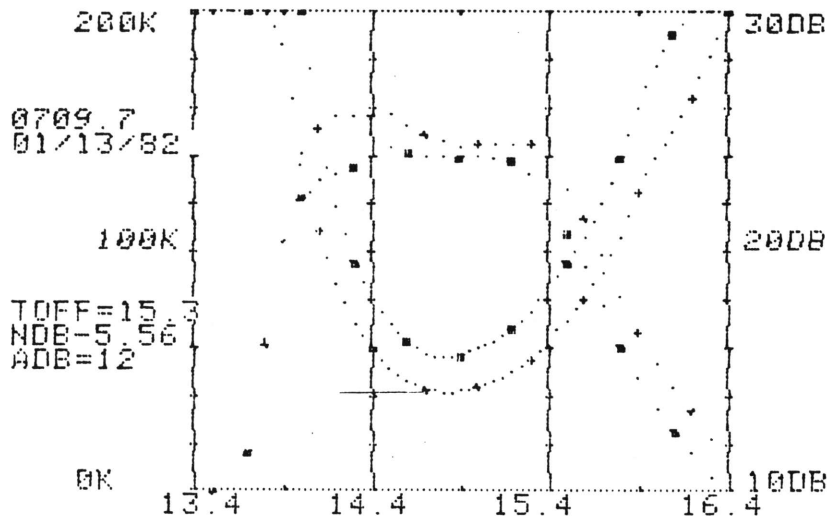


Fig. 15. Gain and noise temperature of amplifier #112 at 300K (top) and 20K (bottom) with 15 ohm input quarter-wave transformer. The 20K results are shown for first stage drain voltages of 5 volts and 4 volts (optimum).

REFERENCES

- [1] Sander Weinreb, "Low-Noise Cooled GASFET Amplifiers," IEEE Trans. on Microwave Theory and Tech., vol. MTT-28, no. 10, October 1980.
- [2] G. Tomassetti, S. Weinreb, and K. Wellington, "Low-Noise 10.7 GHz Coo GaAs FET Amplifier," Electronics Letters, vol. 17, no. 25/26, pp. 949-951, December 10, 1981.
- [3] D. L. Fenstermacher, "A Computer-Aided Analysis Routine Including Optimization for Microwave Circuits and Their Noise," NRAO Elect Division Internal Report No. 217, July 1981.

Appendix I

Program "R_{opt} 1" for HP-9845A Computer

Equations

This program computes the noise parameters (other than X_{opt}) from a set of N measurements (N ≥ 3) by minimizing the mean square error between the calculate and measured noise temperatures. The function to be adjusted is:

$$T(R) = T_{\min} + T_0 G_n (R - R_{\text{opt}})^2 / R \quad (1)$$

where T₀ = 290K and T_{min}, G_n and R_{opt} are unknowns. Having N points T_i, R_i where i = 1 to N, the mean square error is:

$$E = \sum (T(R_i) - T_i)^2$$

and the rms error of the fit, in degrees Kelvin, is $\sqrt{E/N}$. The set of three equations that allows us to compute the noise parameters is:

$$\partial E / \partial T_{\min} = 0$$

$$\partial E / \partial R_{\text{opt}} = 0$$

$$\partial E / \partial G_n = 0$$

Letting $\Delta t_i = T_{\min} + T_0 G_n (R_i - R_{\text{opt}})^2 / R_i - T_i$, this set of equations can be interpreted as:

$$\sum \Delta t_i = 0$$

$$\sum \Delta t_i / R_i = 0$$

$$\sum \Delta t_i \cdot R_i = 0$$

The unknowns can be extracted from these three equations and finally written as follows:

$$R_{opt}^2 = \frac{R_r T_g - R_g T_r}{G_g T_r - R_g T_g}$$

$$T_o G_n = \frac{T_g}{R_g + R_{opt}^2 G_g} = \frac{G_g T_r - R_g T_g}{G_g R_r - R_g^2}$$

$$T_{min} = \frac{1}{N} [T - T_o G_n (R - 2R_{opt} N + R_{opt}^2 G)]$$

where $R = \sum R_i$, $G = \sum 1/R_i$, $T = \sum T_i$, and

$$R_r = (\sum R_i)^2 - N \sum R_i^2$$

$$R_g = \sum R_i \sum 1/R_i - N^2$$

$$G_g = (\sum 1/R_i)^2 - N \sum 1/R_i^2$$

$$T_r = \sum T_i \sum R_i - N \sum T_i R_i$$

$$T_g = \sum T_i \sum 1/R_i - N \sum T_i / R_i$$

How the Program Works

The program reads the number of points and values from data statements computes the three noise parameters and the final error in temperature and presents the function T(R) in graphics mode.

Two operation modes are allowed:

Option = 0: uses the data as temperature and source
resistance values

Option = 1: uses the data as temperature, $\lambda/4$ transformer
impedance and 50 ohm line length (inches)

From this, it is clear that three values are required for each point and that the third one is not used in the zero option.

The scale in the plotting can be changed easily through the variables X_{\max} and Y_{\max} that are the maximum values for horizontal and vertical dimensions of the plot.

```
10 ! THIS PROGRAM COMPUTES THE MINIMUM TEMPERATURE AND OPTIMUM
20 ! SOURCE RESISTOR FROM A SET OF N MEASUREMENTS WITH THE
30 ! MINIMUM QUADRATIC ERROR
40 PRINT LIN(2),"Ropt 1 as of 12/10/81"
50 OPTION BASE 1
60 ! DATA must be placed in 470 to 510 as follows: N,T1,R1,L1,T2
70 ! Select Option=0 for Ri=Rsource and Option=1 for R=Rtransfor
   L=50 ohm line length
80 INPUT "Option=",Option
81 Fo=15
85 Qlam=11.8028527/(2*Fo)
90 DIM Temp(20),Res(20),Long(20)
100 READ N
110 REDIM Temp(N),Res(N),Long(N)
120 R=G=T=Rn=ug=Tr=Tg=0
130 FOR I=1 TO N
140 READ Temp(I),Res(I),Long(I)
150 IF Option=0 THEN 170
152 L=PI*Long(I)/(2*Qlam)
160 Res(I)=Res(I)^2*(1+TAN(L)^2)/(50*(1+((Res(I)/50)^2*TAN(L))^2)
170 R=R+Res(I)
180 G=G+1/Res(I)
190 T=T+Temp(I)
200 Rn=Rn+Res(I)^2
210 Gg=Gg+1/Res(I)^2
220 Tr=Tr+Temp(I)*Res(I)
230 Tg=Tg+Temp(I)/Res(I)
240 NEXT I
250 Rn=R^2-N*Rn
260 Rg=R*G-N^2
270 Gg=G^2-N*Gg
280 Tr=T*R-N*Tr
290 Tg=T*G-N*Tg
300 Ropt=SQR(ABS((Rg*Tr-Rn*Tg)/(Rg*Tg-Gg*Tr)))
310 Gn=Tr/(Rn+Ropt^2*Rg)
320 Tmin=T/N-Gn*(R/N-2*Ropt+G*Ropt^2/N)
330 Error=0
340 FOR I=1 TO N
350 Error=Error+(Tmin+Gn*(Ropt-Res(I))^2/Res(I)-Temp(I))^2
360 NEXT I
370 Error=SQR(Error/N)
380 Gn=Gn/290
390 INPUT "Print title in less than 18 characters",A#
400 PRINT LIN(1),TAB(20);A#
410 PRINT "-----"
420 PRINT LIN(1),"Minimum temperature Tmin=";Tmin
430 PRINT "Optimum resistance Ropt=";Ropt
440 PRINT "Noise conductance Gn=";Gn
450 PRINT "Mean square error Err=";Error
460 PRINT LIN(1),"-----"
470 DATA 3
480 DATA 75.5,34,.07
490 DATA 46.9,22,.055
500 DATA 31.7,12,.052
510 DATA 66.7,34,0
520 GRAPHICS
521 Xmax=12
522 Ymax=110
530 SCALE -.1*Xmax,Xmax, -.1*Ymax,Ymax
540 AXES 10,50,0,0,5,2,5
550 LINE TYPE 1
560 LOG 6
570 MOVE -.03*Xmax,-.03*Ymax
580 LABEL USING "k";"0"
590 MOVE 10, -.03*Ymax
600 LABEL USING "k";"10"
```

```

610 MOVE .5*Xmax,-.07*Ymax
620 LABEL USING "K";"Rsource(ohm)"
630 LORG 8
640 MOVE -.03*Xmax,100
650 LABEL USING "K";"100"
660 MOVE -.03*Xmax,.8*Ymax
670 LABEL USING "K";"T(K)"
680 LORG 5
690 FOR I=1 TO N
700 MOVE Res(I),Temp(I)
710 LABEL USING "K";"+"
720 NEXT I
730 FOR Ri=.01*Xmax TO Xmax STEP .01
740 Ti=Tmin+290*Gn*(Ri-Ropt)^2/Ri
750 PLOT Ri,Ti
760 NEXT Ri
770 PAUSE
771 RESTORE
772 GOTO 100
780 END

```

Appendix 1. Program "R₀"

Appendix 2

NE-137 and MGF-1412 Models

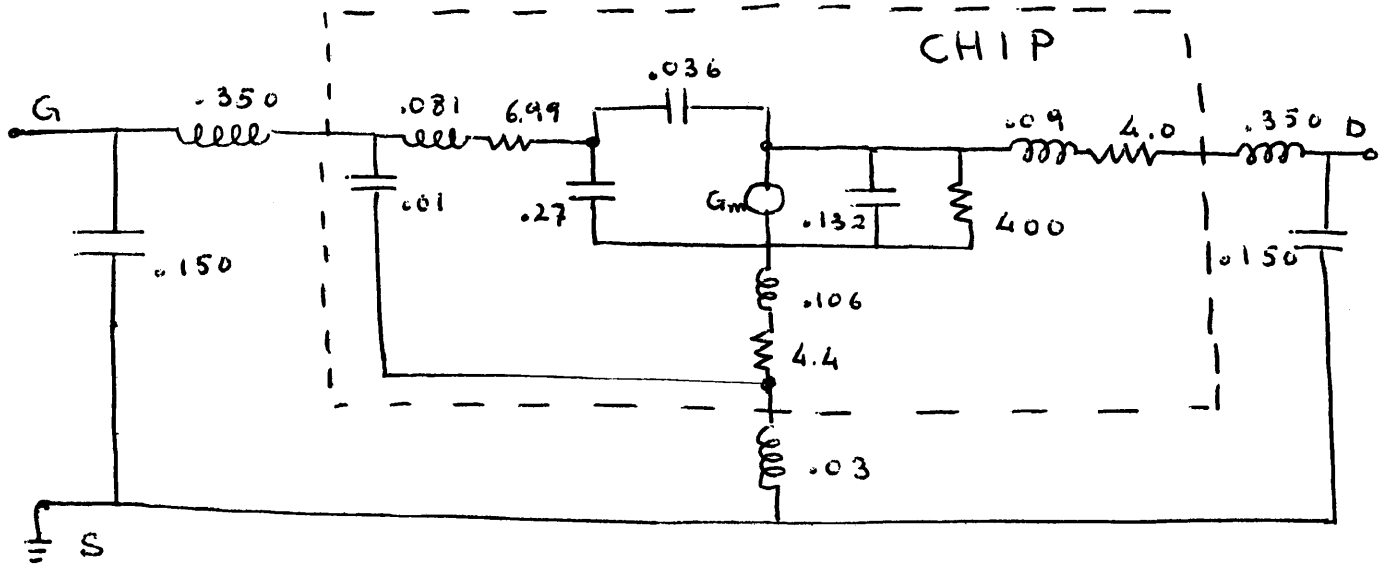
The circuit models used in the computer programs for the NE-137 and MGF-1412 FET's are shown in Figures A2-1 and A2-2, where the package is outside the dotted lines.

The scattering parameters computed from these models and the computer program which calculates the transistor performances at any frequency are included in Figures A2-3 to A2-6.

The computer description of the circuit models is as follows:

```
7955 Fct:1 NE 137 Model at 300K          01/27/82
7960 DISP "Analyzing the ckt model . . . FREQ =";F
7965 CALL Rlc(A(*),"S",0,0,.036,"S",0)      IC2
7970 CALL Ss(Sc(B(*),"V","C",45.6,1E7,400.9,1.28)  Igm,R4,T
7975 CALL Par(B(*),A(*))
7980 CALL Rlc(A(*),"S",0,0,.270,"P",0)      IC1
7985 CALL Cas(A(*),B(*))
7990 CALL Rlc(B(*),"S",0,0,.132,"P",0)      IC3
7995 CALL Cas(A(*),B(*))
8000 CALL Rlc(B(*),"S",4.4,.106,0,"P",0)    IR2,L2
8005 CALL Ser(B(*),A(*))
8010 CALL Rlc(A(*),"S",6.99,.081,0,"S",0)   IR1,L1
8015 CALL Cas(A(*),B(*))
8020 CALL Rlc(B(*),"S",4,.090,0,"S",0)     IR3,L3
8025 CALL Cas(A(*),B(*))
8030 CALL Rlc(B(*),"S",0,0,.01,"P",0)      IC4
8035 CALL Cas(B(*),A(*))                   INE 13700 in IB
8066 Tmin=152*F/15
8067 Ropt=6.64*15/F
8068 Xopt=27.03*15/F
8069 Gm=26.5*(F/15)^2
8070 CALL Nload(B(*),4,Tmin,Ropt,Xopt,Gm)
8071 CALL Rlc(A(*),"S",0,.350,0,"S",0)      IPackaging L's
8072 CALL Cas(B(*),A(*))
8075 CALL Cas(A(*),B(*))
8076 CALL Rlc(B(*),"S",0,0,.150,"P",0)     IPackaging C's
8077 CALL Cas(A(*),B(*))
8078 CALL Cas(B(*),A(*))
8079 CALL Rlc(A(*),"P",0,.03,0,"P",0)      ISource L-C
8080 CALL Ser(A(*),B(*))
8165 DISP
8170 RETURN
```

```
7955 Part1 MGF-1412 model
7960 DISP "Analyzing the ckt model . . . . FREQ =";F
7965 CALL Rlc(A(*),"S",0,0,.031,"S",0) !C2
7970 CALL Source(B(*),"V","C",44.0,1E7,500.0,5) !gm,R4,T
7975 CALL Pwr(B(*),A(*))
7980 CALL Rlc(A(*),"S",0,0,.500,"P",0) !C1
7985 CALL Cap(A(*),B(*))
7990 CALL Rlc(B(*),"S",0,0,.350,"P",0) !C3
7995 CALL Cap(A(*),B(*))
8000 CALL Rlc(B(*),"S",2.0,.009,0,"P",0) !R2,L2
8005 CALL Ser(B(*),A(*))
8010 CALL Rlc(A(*),"S",4,.100,0,"S",0) !R1,L1
8015 CALL Cap(A(*),B(*))
8020 CALL Rlc(B(*),"S",3,.050,0,"S",0) !R3,L3
8025 CALL Cap(A(*),B(*))
8030 CALL Rlc(B(*),"S",0,0,.01,"P",0) !C4
8035 CALL Cap(B(*),A(*)) !Chip model in
8036 Tmin=290*F/15
8037 Ropt=17.5*15/F
8038 Xopt=16.0*15/F
8039 G=20.8*(F/15)^2
8040 CALL Nload(B(*),4,Tmin,Ropt,Xopt,G) !Noise model at
8065 CALL Rlc(A(*),"S",0,.300,0,"S",0) !Packaging L's
8070 CALL Cap(B(*),A(*))
8075 CALL Cap(A(*),B(*))
8076 CALL Rlc(B(*),"S",0,0,.450,"P",0) !Packaging Cout
8079 CALL Cap(A(*),B(*))
8080 CALL Rlc(B(*),"S",0,0,.250,"P",0) !Packaging Cin
8081 CALL Cap(B(*),A(*))
8082 CALL Rlc(A(*),"P",0,.03,0,"P",0) !Source L-C
8083 CALL Ser(A(*),B(*))
8165 DISP
8170 RETURN
8260 SUBEND
```



$|G_m| = 45.6$ $\tau = 1.28 \text{ ps.}$

Fig. A2-1. Circuit model of NE13783.

MGF-1412

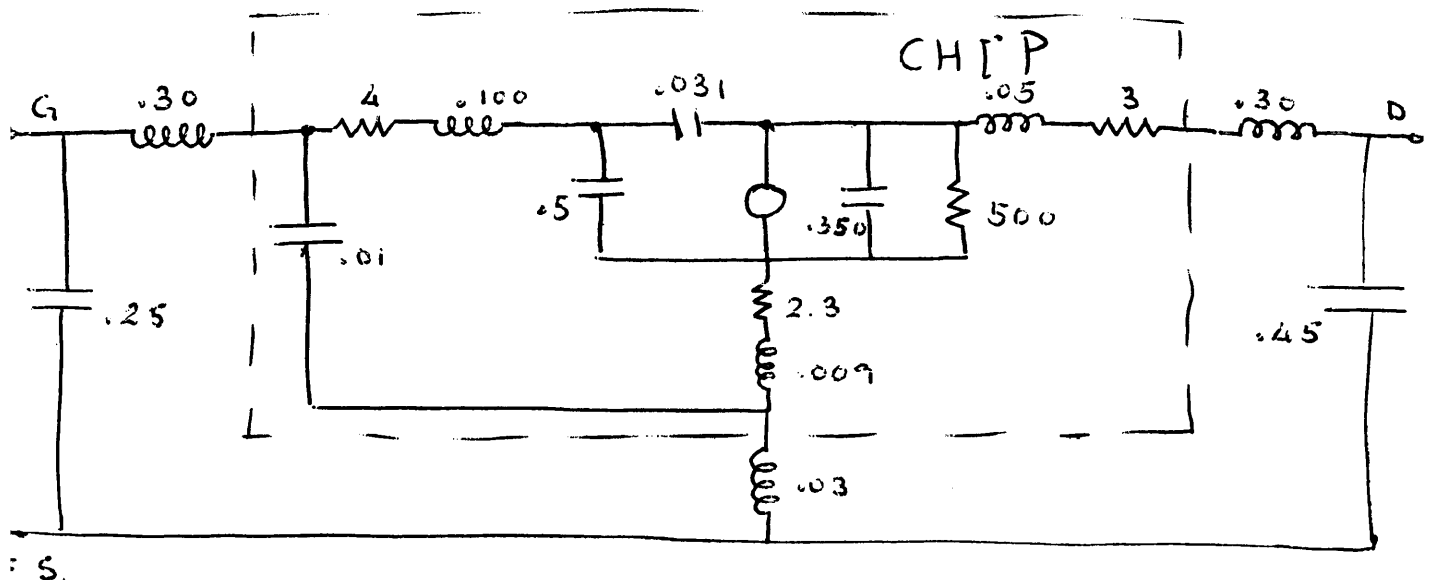


Fig. A2-2. Circuit model of MGF-1412.

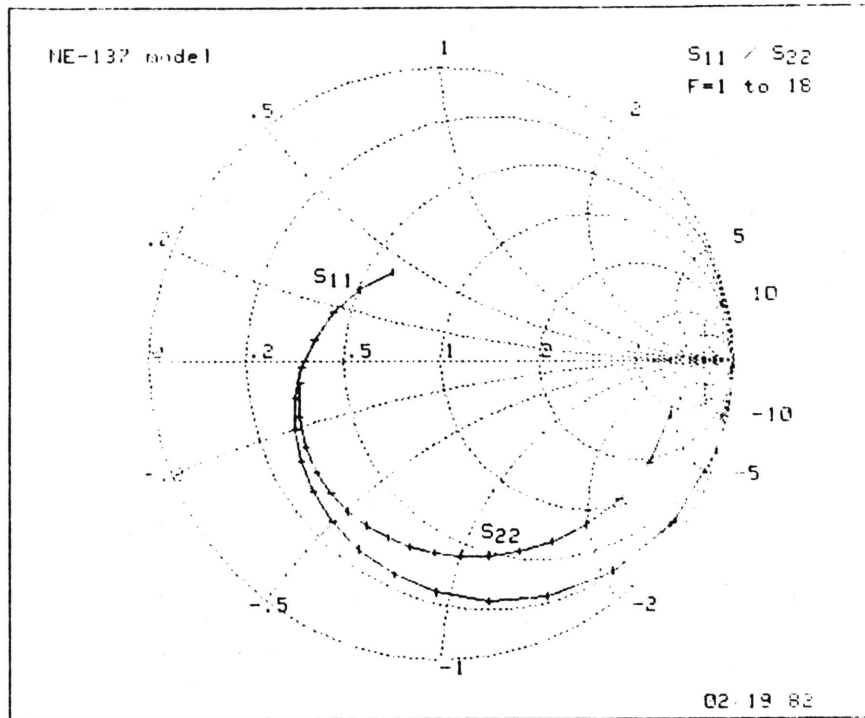


Fig. A2-3. S11 and S22 of NE13783 model.

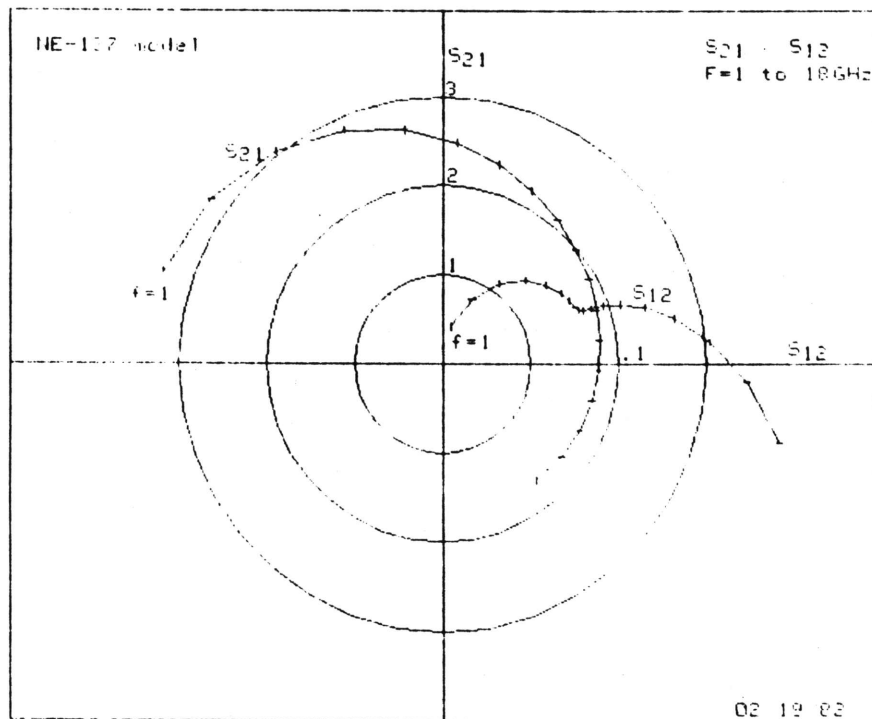


Fig. A2-4. S21 and S12 of NE13783 model.

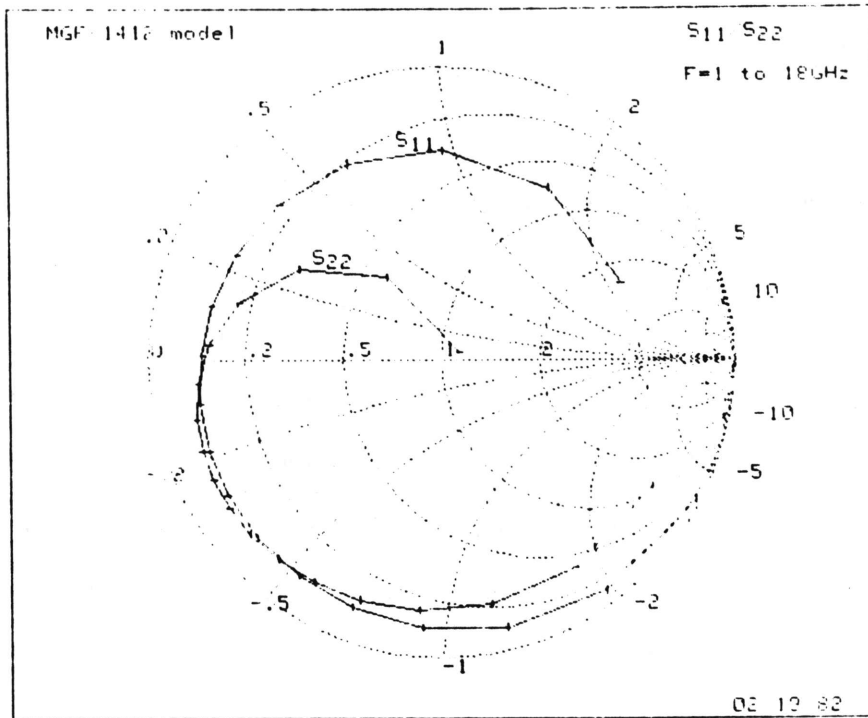


Fig. A2-5. S_{11} and S_{22} of MGF-1412 model.

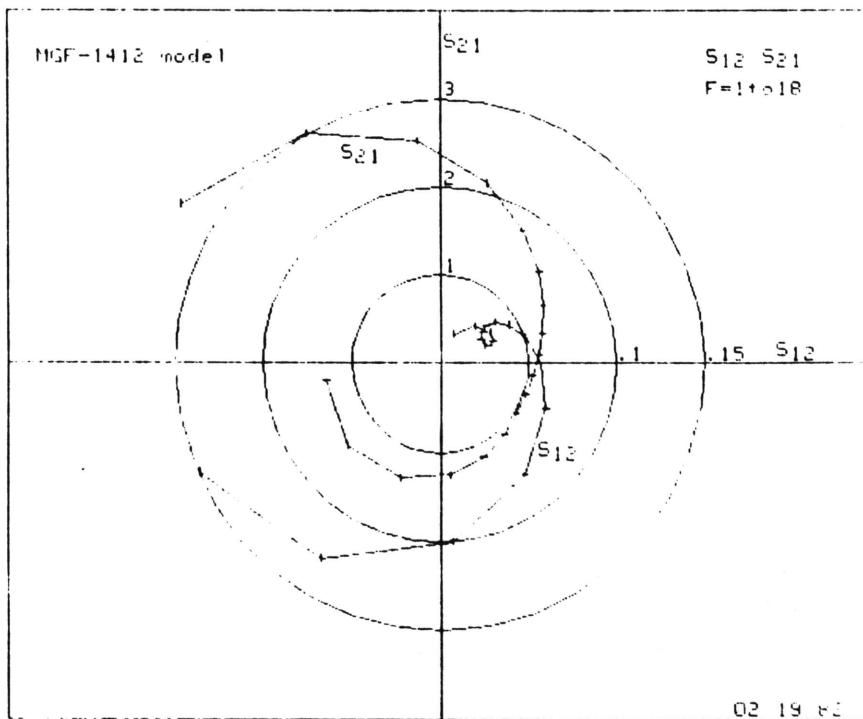


Fig. A2-6. S_{12} and S_{21} of MGF-1412 model.

Appendix 3

Noise Measurement Errors

In this analysis we are going to look only at the errors in the noise measurements due to the second stage or receiver noise when it is taken into account and subtracted from the total noise measured.

Let us define the receiver as shown in Fig. 4 where R_{ij} are the scattering parameters and n_{20} , n_{2i} are the noise waves at the receiver input.

In the calibration process, the power in the load can be written as:

$$P_L = |R_{21}|^2 \cdot \frac{[T_{2i} + T_{20}|\Gamma_s|^2 + 2\text{Re}(\Gamma_s\zeta_2) + T_s(1 - |\Gamma_s|^2)]}{|1 - \Gamma_s R_{11}|^2}$$

or $P_L = G_R(T_R + T_s)(1 - |\Gamma_s|^2)$ where

$$G_R = \left| \frac{R_{21}}{1 - \Gamma_s R_{11}} \right|^2$$

$$T_R = \frac{T_{2i} + T_{20}|\Gamma_s|^2 + 2\text{Re}(\Gamma_s\zeta_2)}{1 - |\Gamma_s|^2}$$

$$T_{2i} = \overline{|n_{2i}|^2}$$

$$T_{20} = \overline{|n_{20}|^2}$$

$$\zeta_2 = \overline{n_{20}n_{2i}^*}$$

Using two source temperatures (T_1, T_0), with excess noise $N_s = T_1/T_0 - 1$, the receiver temperature and gain can be computed as follows:

$$T_R = T_0 \left(\frac{N_s}{N_R} - 1 \right)$$

$$G_R = \frac{1}{1 - |\Gamma_s|^2} \cdot \frac{P_o}{T_0} \left(\frac{N_R}{N_s} \right)$$

where $N_R = \frac{P_1}{P_o} - 1$, $P_o = P_L(T_s = T_0)$ and $P_1 = P_L(T_s = T_1)$

In the most general situation, the device under test can be described as shown in Figure A3-2. When it has been inserted, the power in the load is:

$$P_L' = \frac{|R_{21}|^2}{|1 - \Gamma_2 R_{11}|} \left[T_{2i} + |\Gamma_2|^2 \cdot T_{20} + 2\text{Re}(\Gamma_2 \cdot \zeta_2) \right. \\ \left. + \frac{|S_{21}|^2}{|1 - \Gamma_1 \Gamma_s|^2} \left(T_{1i} + T_{10} |\Gamma_s|^2 + 2\text{Re}(\Gamma_s \zeta_1) + T_s (1 - |\Gamma_s|^2) \right) \right]$$

or $P_L' = G_{Re} [T_{Re} (1 - |\Gamma_2|^2) + G_A (T_A + T_s) (1 - |\Gamma_s|^2)]$

where

$$G_{Re} = \frac{|R_{21}|^2}{|1 - \Gamma_2 R_{11}|^2}$$

$$G_A = \frac{|S_{21}|^2}{|1 - \Gamma_s \Gamma_1|^2}$$

$$T_{Re} = \frac{T_{2i} + T_{20} |\Gamma_e|^2 + 2\text{Re}(\Gamma_2 \zeta_2)}{1 - |\Gamma_2|^2}$$

$$T_A = \frac{T_{1i} + T_{10} |\Gamma_s|^2 + 2\text{Re}(\Gamma_s \zeta_1)}{1 - |\Gamma_s|^2}$$

In the same way as in the calibration process, the total input noise and gain can be computed as:

$$T_T = T_O \left(\frac{N_S}{N_A} - 1 \right)$$

$$G_T(1 - |\Gamma_S|^2) = \frac{P'_O}{T_O} \cdot \frac{N_A}{N_S} \quad .$$

where $N_A = \frac{P'_1}{P'_O} - 1$, $P'_O = P'_L(T_S = T_O)$ and $P'_1 = P'_L(T_S = T_1)$

Using the gain and noise definitions as before, it follows that:

$$T_T = T_A + T_{Re} \cdot \frac{(1 - |\Gamma_2|^2)}{G_A(1 - |\Gamma_S|^2)} = T_A + \frac{T_{Re}}{G_{av}}$$

$$G_T = G_{Re} \cdot G_A$$

It can be seen that the values for the receiver noise and gain used in these equations are not exactly the same values measured in the calibration process.

First, the computed gain is

$$G'_{av} = G_T/G_R$$

or using the available gain as before

$$G_A = G'_{av} \left[\frac{(1 - |\Gamma_S|^2) |1 - \Gamma_2 R_{11}|^2}{(1 - |\Gamma_2|^2) |1 - \Gamma_S R_{11}|^2} \right]$$

On the other hand, the receiver noise changes as the source impedance does, and the real noise can be written as a function of the measured one as follows:

$$T_{Re} = (T_R + \Delta T) \cdot \frac{1 - |\Gamma_s|^2}{1 - |\Gamma_2|^2}$$

$$\text{where } \Delta T = \frac{1}{1 - |\Gamma_s|^2} \left[T_{20}(|\Gamma_2|^2 - |\Gamma_2|^2) + 2\text{Re} \left(\zeta_2(\Gamma_2 - \Gamma_s) \right) \right]$$

The final error in the amplifier noise temperature is:

$$\Delta T_A = \Delta T \cdot \frac{1}{G'_{av}} \left| \frac{1 - \Gamma_s R_{11}}{1 - \Gamma_2 R_{11}} \right|^2 - \frac{T_{Rm}}{G'_{av}} \left(1 - \left| \frac{1 - \Gamma_s R_{11}}{1 - \Gamma_2 R_{11}} \right|^2 \right)$$

where the first term is mainly due to the variation in the receiver noise temperature when changing its source impedance and the second one is due to the error in the amplifier available gain and the second stage noise contribution.

If the second stage is connected through an isolator at temperature T_1 and the noise source is well-matched, as usually happens, the error can be written as follo

$$\Delta T_A \approx \frac{T_1 \cdot |\Gamma_2|^2}{G |1 - \Gamma_2 R_{11}|^2} - \frac{T_{Rm}}{G} \left(1 - \frac{1}{|1 - \Gamma_2 R_{11}|^2} \right)$$

which is limited, depending on the sign of Γ_2 and R_{11} phases by the maximum and minimum values as follows:

$$\Delta T_{Amax} = \left(T_1 |\Gamma_2|^2 + 2T_{Rm} |\Gamma_2 R_{11}| \right) \cdot \frac{1}{G \cdot (1 + |\Gamma_2 R_{11}|)^2}$$

$$\Delta T_{Amin} = \left(T_1 |\Gamma_2|^2 - 2T_{Rm} |\Gamma_2 R_{11}| \right) \cdot \frac{1}{G(1 + |\Gamma_2 R_{11}|)^2}$$

where G = amplifier measured gain.

Appendix 4

Amplifier Design Computer Programs

The most important programs which compute the matching networks and analyze the amplifier frequency response are presented in this appendix.

Two-Stage Amplifier Design "Man #4"

This program computes a two-stage amplifier for minimum noise and optimizes the input return loss changing the inter-stage free parameter.

The method is as follows:

1. Compute the transistor model and get R_{opt} .
2. Loading the input with R_{opt} , compute R_{out} .
3. Compute the input return loss for three values of the inter-stage "trombone line" (free parameter).
4. As the three values for the input reflection coefficient must be in a circle, it is easy to know the minimum and go back with this point to the inter-stage circuit.
5. Compute the circuit parameters and print these.
6. Compute the frequency response and plot it.

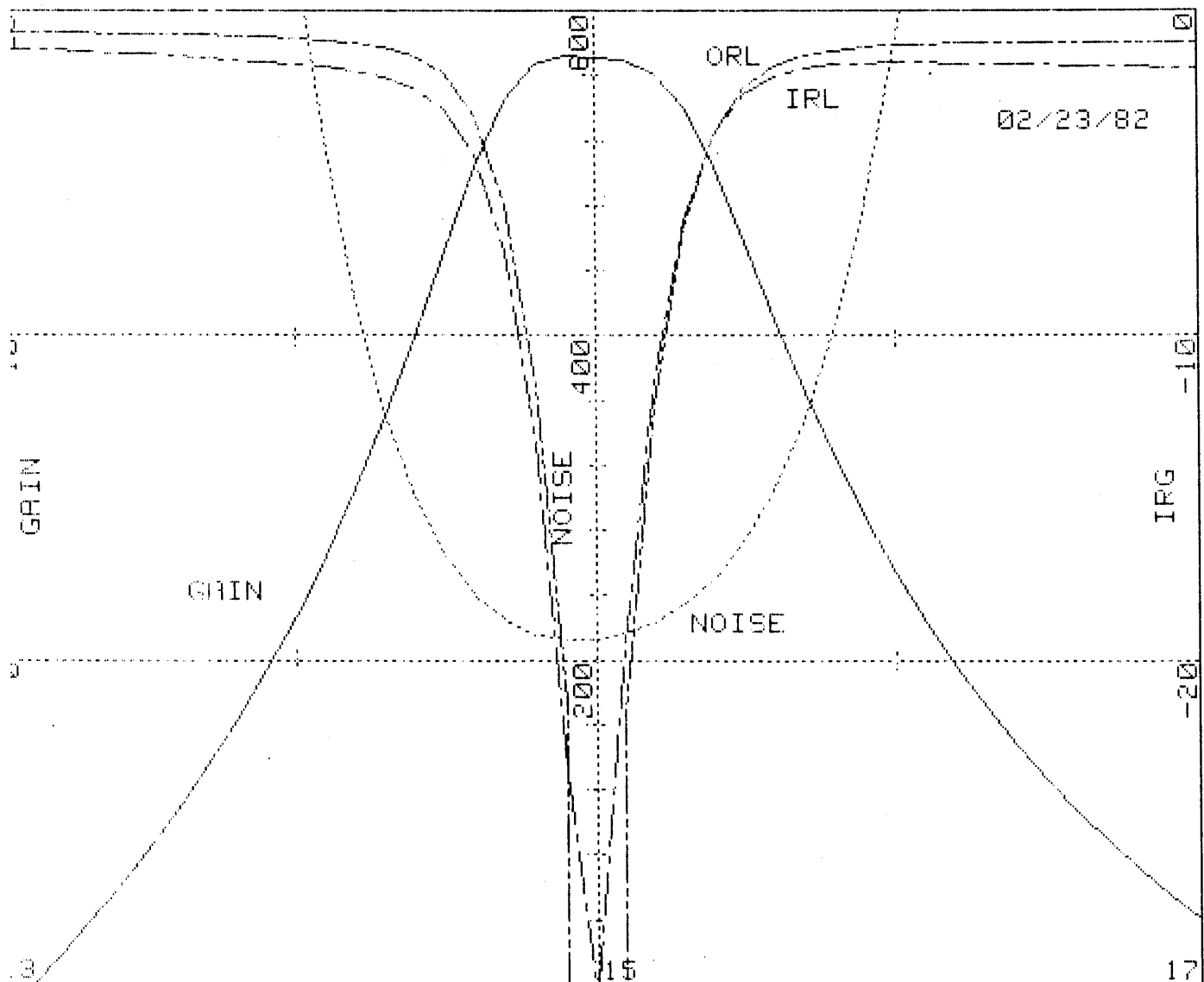
The list and usual printout are presented here for the NE-137 room temperature amplifier model (two-stage).

Man#4 as of 8/20/81
design frequency= 15
stimun noise impedance=

Source L1= .03

Source L2= .03

| | | | |
|-----------------|--------------|---------------------|-----------------|
| | First stage | Zopt= 7.74900446231 | j 22.0042182449 |
| | Second stage | Zopt= 7.74900446231 | j 22.0042182449 |
| combone length= | .170983 | Rin1= 52.218 | Xin1=-2.33208 |
| line number 1 | Zo= 17.9864 | Length= | .196714 |
| line number 2 | Zo= 50 | Length= | .0528602 |
| line number 3 | Zo= 50 | Length= | .0920018 |
| line number 4 | Zo= 12.9635 | Length= | .196714 |
| line number 5 | Zo= 50 | Length= | .170983 |
| line number 6 | Zo= 17.9864 | Length= | .196714 |
| line number 7 | Zo= 50 | Length= | .0528602 |
| line number 8 | Zo= 50 | Length= | .0920018 |
| line number 9 | Zo= 12.9635 | Length= | .196714 |



```
Man#4 as of 8/20/81
6195 SUB Cktanalysis(J(*),Fvalue,Opt)
6205 PRINT LIN(2);TAB(10);"Man#4 as of 8/20/81"
6215 OPTION BASE 1
6225 COM Nogo,Zo,F,Count,SHORT Dat(51,18) ! [DAT] HOLDS FREQ, CKT AND NOISE DA
6235 DIM A(6,4),B(6,4),C(6,4),D(6,4),E(4,4),Y(9),Z(8),W(9)
6245 STANDARD
6255 Count=Nogo=0 !#FREQS CURRENTLY STORED IN DATA BASE
6265 Zt=50
6275 Zo=50
6285 DEG !DEFAULT FOR TRIG FUNCTIONS IS DEGREES
6295 REM USER'S PROGRAM SHOULD BEGIN ON THE NEXT LINE, USING AN INCREMENT OF 1
6305 ! This program computes a two-stage amp. matched for optimum noise
6315 ! and output return loss in both stages, and select the interstage
6325 ! line length (Trombone line) for optimum input match @ Fo.
6335 Fo=15
6345 F1=13
6355 F2=17
6365 Df=.100
6375 F=Fo
6385 Qlam=11.8028527/(4*F)
6395 INPUT "Source L1 and L2 =",L1,L2
6405 L=L1
6415 GOSUB Fet
6425 MAT C=A
6435 CALL Ntrans(C(*),4)
6445 Ropt1=C(6,2)
6455 Xopt1=C(6,3)
6465 L=L2
6475 GOSUB Fet
6485 CALL Ntrans(A(*),4)
6495 Ropt2=A(6,2)
6505 Xopt2=A(6,3)
6515 PRINT "Design frequency=";F;TAB(30);"Source L1=";L1;TAB(60);"Source L2=";L
6525 PRINT "Optimum noise impedance="
6535 PRINT TAB(30);"First stage Zopt=";Ropt1;" j";Xopt1
6545 PRINT TAB(30);"Second stage Zopt=";Ropt2;" j";Xopt2
6555 CALL Zio(C(*),Ropt1,Xopt1,0,0,0,0,Z(3),Z(4),1)
6565 CALL Zio(A(*),Ropt2,Xopt2,0,0,0,0,Z(7),Z(8),1)
6575 CALL Gammaz(-1,C,D,Ropt1,Xopt1)
6585 Y(1)=Zo*SQR((1-C)/(1+C))
6595 W(1)=Qlam
6605 Y(2)=Zo
6615 W(2)=(1-D/180)*Qlam
6625 Zo=Zt
6635 CALL Gammaz(-1,C,D,Z(3),Z(4))
6645 Y(3)=Zo
6655 W(3)=(1+D/180)*Qlam
6665 Y(4)=Zo*SQR((1-C)/(1+C))
6675 W(4)=Qlam
6685 CALL Gammaz(-1,C,D,Ropt2,Xopt2)
6695 Y(6)=Zo*SQR((1-C)/(1+C))
6705 W(6)=Qlam
6715 Y(7)=Zo
6725 W(7)=(1-D/180)*Qlam
6735 Zo=50
6745 CALL Gammaz(-1,C,D,Z(7),Z(8))
6755 Y(9)=Zo*SQR((1-C)/(1+C))
6765 W(9)=Qlam
6775 Y(8)=Zo
6785 W(8)=(1+D/180)*Qlam
6795 L=L1
6805 K=1
6815 GOSUB Circuit
```


=A

```
6845 K=2
6855 GOSUB Circuit
6865 CALL Zio(A(*),0,0,50,0,Z(5),Z(6),0,0,1)
6875 E=0
6885 FOR K=1 TO 3
6895   Zo=Zt
6905   CALL Gammaz(-1,A,B,Z(5),Z(6))
6915   H=B-2*E
6925   CALL Gammaz(1,A,H,E(1,K),E(2,K))
6935   Zo=50
6945   CALL Zio(C(*),0,0,E(1,K),E(2,K),E(3,K),E(4,K),0,0,1)
6955   CALL Gammaz(-2,E(1,K),E(2,K),E(3,K),E(4,K))
6965   E(3,K)=E(1,K)^2+E(2,K)^2
6975   E=E+60
6985 NEXT K
6995 D=(E(2,1)-E(2,3))*(E(1,1)-E(1,2))-(E(2,1)-E(2,2))*(E(1,1)-E(1,3))
7005 IF D=0 THEN 7105
7015 E(1,4)=E(2,1)*(E(3,3)-E(3,2))+E(2,2)*(E(3,1)-E(3,3))+E(2,3)*(E(3,2)-E(3,1))
7025 E(2,4)=E(1,1)*(E(3,3)-E(3,2))+E(1,2)*(E(3,1)-E(3,3))+E(1,3)*(E(3,2)-E(3,1))
7035 E(1,4)=E(1,4)/(2*D)
7045 E(2,4)=-E(2,4)/(2*D)
7055 R=SQR((E(1,4)-E(1,1))^2+(E(2,4)-E(2,1))^2)
7065 D=SQR(E(1,4)^2+E(2,4)^2)
7075 E(3,4)=E(1,4)*(1-R/D)
7085 E(4,4)=E(2,4)*(1-R/D)
7095 GOTO 7135
7105 D=(E(2,1)*E(1,2)-E(2,2)*E(1,1))/((E(1,1)-E(1,2))^2+(E(2,1)-E(2,2))^2)
7115 E(3,4)=(E(2,1)-E(2,2))*D
7125 E(4,4)=(E(1,2)-E(1,1))*D
7135 CALL Gammaz(2,E(3,4),E(4,4),C,D)
7145 CALL Zio(C(*),0,0,Z1,Z2,C,D,0,0,-1)
7155 Zo=Zt
7165 CALL Gammaz(-1,G,H,Z1,Z2)
7175 IF ABS(A-G)<1E-6 THEN 7215
7185   PRINT "Gamma in both ends of the trombone line don't match"
7195   PRINT "Left end abs. gamma=";G;"Right end abs. gamma=";A
7205   PAUSE
7215 E=(B-H)*0.1am/180
7225 IF E<0 THEN E=E+2*0.1am
7235 Zo=50
7245 PRINT "Trombone length=";DROUND(E,6);
7255 PRINT " Rin1=";DROUND(C,6);" Xin1=";DROUND(D,6)
7265 INPUT "Do you want to change the trombone length?",A$
7275 IF A$="N" THEN 7305
7285 INPUT "Trombone length=",E
7295 PRINT "New trombone length =" ;E
7305 Y(5)=2t
7315 W(5)=E
7325 FOR K=1 TO 9
7335   PRINT "Line number";K;" Zo=";DROUND(Y(K),6),"Length=";DROUND(W(K),6)
7345 NEXT K
7355 FOR F=F1 TO F2 STEP Df
7365   L=L2
7375   K=2
7385   GOSUB Circuit
7395   MAT C=A
7405   L=L1
7415   K=1
7425   GOSUB Circuit
7435   CALL Trline(B(*),Y(5),W(5),1)
7445   CALL Cas(B(*),C(*))
7455   CALL Cas(A(*),B(*))
7465   CALL Saveckt(A(*),4,4,-1)
7475   CALL Nperformance(A(*),0,50,0,50,0,G,1)
```

```
5 NEXT F
5 GRAPHICS
7505 SCALE F1,F2,-30,0
7515 C=4/236.2 !GHz/mm
7525 D=30/162.5 !dB/mm
7535 LINE TYPE 3
7545 AXES 1,2,Fo,-10
7555 AXES 1,10,Fo,-20
7565 LINE TYPE 5
7575 FOR K=1 TO Count
7585 PLOT Dat(K,1),10*LGT(Dat(K,2)^2+Dat(K,3)^2) !S11 is dot-dashe
7595 NEXT K
7605 PENUP
7615 LINE TYPE 3
7625 FOR K=1 TO Count
7635 PLOT Dat(K,1),Dat(K,14)/20-30 !noise is dashed
7645 NEXT K
7655 PENUP
7665 LINE TYPE 1
7675 FOR K=1 TO Count
7685 PLOT Dat(K,1),10*LGT(Dat(K,6)^2+Dat(K,7)^2)-20 !S21 is solid
7695 NEXT K
7705 PENUP
7715 LINE TYPE 7
7725 FOR K=1 TO Count
7735 PLOT Dat(K,1),10*LGT(Dat(K,8)^2+Dat(K,9)^2) !S22 is dble dot
7745 NEXT K
7755 LOG 1
7765 G=1
7775 LINE TYPE 1
7785 FOR F=F1 TO F2 STEP 2
7795 IF F<F2 THEN 7825
7805 G=-1
7815 LOG 7
7825 MOVE F+G*C,D-30
7835 LABEL USING "K";F
7845 NEXT F
7855 LDIR 90
7865 FOR G=-20 TO 0 STEP 10
7875 MOVE F2-C,G-D
7885 LABEL USING "K";G
7895 MOVE Fo-C,G-D
7905 LABEL USING "K";20*(G+30)
7915 NEXT G
7925 LOG 4
7935 MOVE F2-5*C,-15
7945 LABEL USING "K";"IRG"
7955 MOVE Fo-5*C,-15
7965 LABEL USING "K";"NOISE"
7975 LOG 6
7985 MOVE F1+5*C,-15
7995 LABEL USING "K";"GAIN"
8005 LOG 9
8015 FOR G=-20 TO 0 STEP 10
8025 MOVE F1+C,G-D
8035 LABEL USING "K";G+20
8045 NEXT G
8055 LDIR 0
8065 FRAME
8075 PAUSE
8085 GOTO 7495
8095 SUBEXIT
8105 Circuit:1
8115 GOSUB Fet
8125 CALL Toline(B(*),Y(5*K-3),W(5*K-3),1)
8135 CALL Cas(B(*),A(*))
```

```

8145 CALL Trline(A(*),Y(5*K-2),W(5*K-2),1)
8155 CALL Cas(B(*),A(*))
8165 CALL Trline(A(*),Y(5*K-4),W(5*K-4),1)
8175 CALL Cas(A(*),B(*))
8185 CALL Trline(B(*),Y(5*K-1),W(5*K-1),1)
8195 CALL Cas(A(*),B(*))
8205 RETURN
8215 Fet: NE-137 Model at 300K          01/27/82
8220 DISP "Analyzing the ckt model . . .   FREQ =";F
8225 CALL Rlc(A(*),"S",0,0,.036,"S",0)      !C2
8230 CALL Source(B(*),"V","C",45.6,1E7,400.9,1.28) !gm,R4,T
8235 CALL Par(B(*),A(*))
8240 CALL Rlc(A(*),"S",0,0,.270,"P",0)      !C1
8245 CALL Cas(A(*),B(*))
8250 CALL Rlc(B(*),"S",0,0,.132,"P",0)      !C3
8255 CALL Cas(A(*),B(*))
8260 CALL Rlc(B(*),"S",4.4,.106,0,"P",0)    !R2,L2
8265 CALL Ser(B(*),A(*))
8270 CALL Rlc(A(*),"S",6.99,.081,0,"S",0)   !R1,L1
8275 CALL Cas(A(*),B(*))
8280 CALL Rlc(B(*),"S",4,.09,0,"S",0)      !R3,L3
8285 CALL Cas(A(*),B(*))
8290 CALL Rlc(B(*),"S",0,0,.01,"P",0)      !C4
8295 CALL Cas(B(*),A(*))                  !NE 13700 in [B]
8300 Tmin=182*F/15
8305 Ropt=6.64*15/F
8310 Xopt=27.33*15/F
8315 Gn=26.5*(F/15)^2
8320 CALL Nload(B(*),4,Tmin,Ropt,Xopt,Gn)   !Noise model
8325 CALL Rlc(A(*),"S",0,.350,0,"S",0)     !Packaging L's
8330 CALL Cas(B(*),A(*))
8335 CALL Cas(A(*),B(*))
8336 CALL Rlc(B(*),"S",0,0,.150,"P",0)     !Packaging C's
8337 CALL Cas(A(*),B(*))
8338 CALL Cas(B(*),A(*))
8339 CALL Rlc(A(*),"P",0,L,0,"P",0)        !Source L
8340 CALL Ser(A(*),B(*))
8344 CALL Trline(B(*),120,.196,1)         !Bias line
8345 CALL Rlc(D(*),"P",50,0,1,"P",0)
8350 CALL Cas(B(*),D(*))
8355 CALL Branch(B(*),"P")
8360 CALL Cas(A(*),B(*))
8365 CALL Cas(B(*),A(*))
8395 CALL Trline(A(*),38,.085,1.8)        !Output coupling
8400 CALL Branch(A(*),"S")
8405 CALL Cas(B(*),A(*))
8410 CALL Trline(A(*),38,.085,1.8)        !Input coupling
8415 CALL Branch(A(*),"S")
8420 CALL Cas(A(*),B(*))
8425 DISP
8430 RETURN
8435 END

```

One to Three Stage Amplifier Design ("Amp #1")

This program allows one to compute the one, two or three stage amplifier, matching each stage for minimum noise or maximum gain as desired.

It does not compute the inter-stage "trombone line" that must be entered during the program execution to allow other than the input match adjustments.

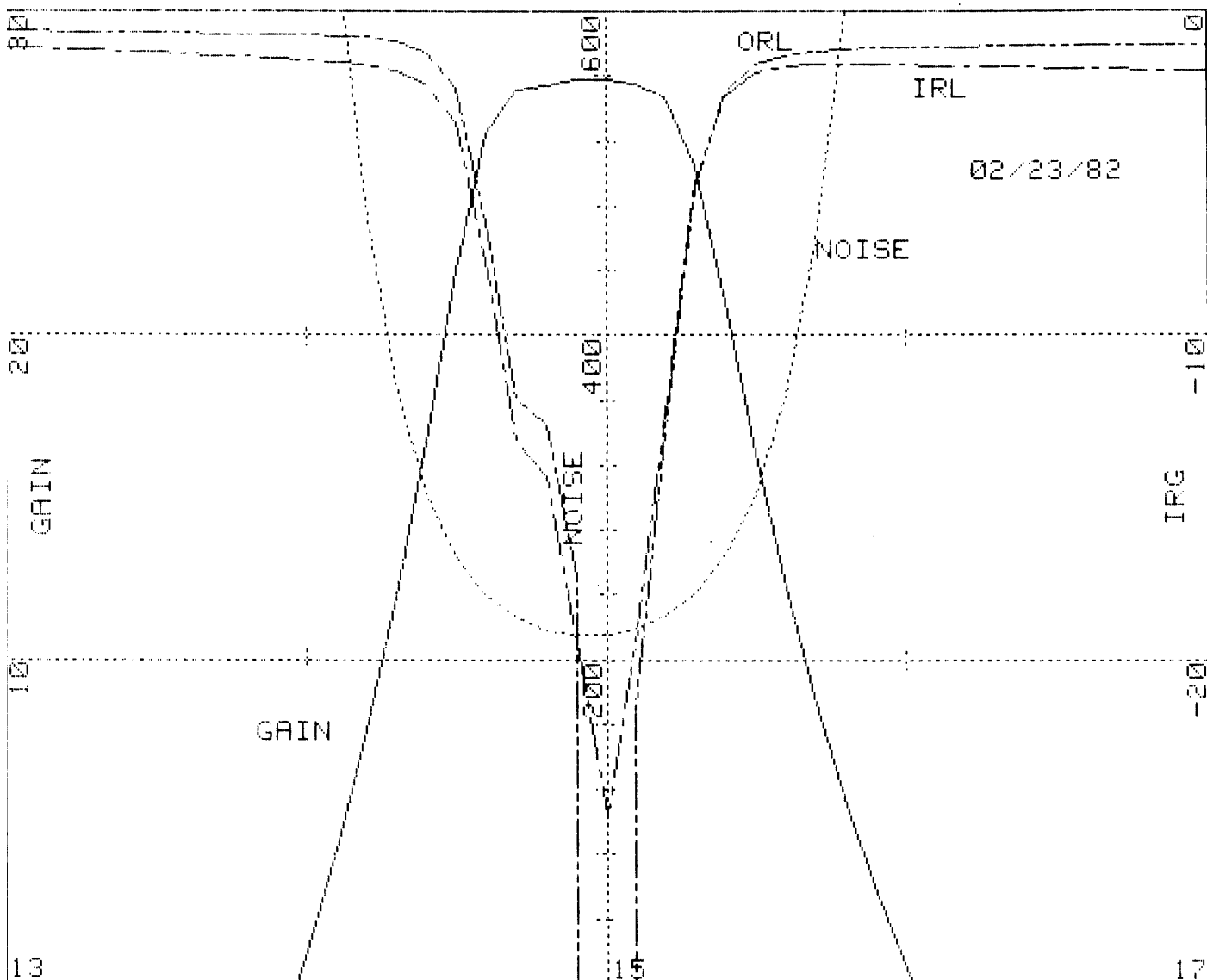
The list and usual printout are presented.

```
Amp#1 as of 9/16/81
Design frequency = 15
Stage # 1          Source L1= .03          Source C1= 0
Minimum noise     Z= 7.749  22.0042 Tmin= 190.665 Ga = 9.28587
Maximum gain      Z= 5.90394 20.7877 Ta = 196.333 Gmax= 9.35016
Min. N. Measure  Z= 7.62539 21.9072 Ta = 190.687 Ga = 9.29371

Stage # 2          Source L1= .03          Source C1= 0
Minimum noise     Z= 7.749  22.0042 Tmin= 190.665 Ga = 9.28587
Maximum gain      Z= 5.90394 20.7877 Ta = 196.333 Gmax= 9.35016
Min. N. Measure  Z= 7.62539 21.9072 Ta = 190.687 Ga = 9.29371

Stage # 3          Source L1= .03          Source C1= 0
Minimum noise     Z= 7.749  22.0042 Tmin= 190.665 Ga = 9.28587
Maximum gain      Z= 5.90394 20.7877 Ta = 196.333 Gmax= 9.35016
Min. N. Measure  Z= 7.62539 21.9072 Ta = 190.687 Ga = 9.29371

Line number 1     Zo= 17.8563          Length= .196714
Line number 2     Zo= 50                  Length= .0526249
Line number 3     Zo= 50                  Length= .092043
Line number 4     Zo= 12.883             Length= .196714
Line number 5     Zo= 50                  Length= .2
Line number 6     Zo= 17.8563           Length= .196714
Line number 7     Zo= 50                  Length= .0526249
Line number 8     Zo= 50                  Length= .092043
Line number 9     Zo= 12.883             Length= .196714
Line number 10    Zo= 50                  Length= .2
Line number 11    Zo= 17.8563           Length= .196714
Line number 12    Zo= 50                  Length= .0526249
Line number 13    Zo= 50                  Length= .092043
Line number 14    Zo= 12.883             Length= .196714
```



```
      Cktanalysis(J(*),Fvalue,Opt)
      Print LIN(2);TAB(10);"Amp#1 as of 9/16/81"
6215 OPTION BASE 1
6225 COM Nogo,Zo,F,Count,SHORT Dat(51,18)  ! [DAT] HOLDS FREQ, CKT AND NOISE D
6235 DIM A(6,4),B(6,4),C(6,4),D(6,4),Y(15),W(15),L(3),Cap(3)
6245 STANDARD
6255 Count=Nogo=0      ! #FREQS CURRENTLY STORED IN DATA BASE
6265 Zo=50
6275 DEG              ! DEFAULT FOR TRIG FUNCTIONS IS DEGREES
6285 REM USER'S PROGRAM SHOULD BEGIN ON THE NEXT LINE, USING AN INCREMENT OF
6295 ! This program computes one, two or three stage amp. tuned for
6305 ! minimum noise, maximum gain or minimum noise figure.
6315 N=3
6325 Fo=15
6335 F1=13
6345 F2=17
6355 Df=.100
6365 F=15
6375 Qlam=11.8028527/(4*Fo)
6385 INPUT "Source L1 and C1 =",L(1),Cap(1)
6395 IF N=1 THEN 6435
6405 INPUT "Source L2 and C2 =",L(2),Cap(2)
6415 IF N=2 THEN 6435
6425 INPUT "Source L3 and C3 =",L(3),Cap(3)
6435 PRINT "Design frequency =";F
6445 FOR K=1 TO N
6455   Ls=L(K)
6465   Cs=Cap(K)
6475   GOSUB Fet
6485   CALL NtrAns(A(*),1)
6495   CALL MtrAns(A(*),1)
6505   Ro=SQR(A(6,1)/A(6,2))
6515   X1=A(6,4)*Ro/A(6,1)
6525   R1=SQR(1-X1^2)
6535   K1=A(6,3)*Ro/A(6,1)
6545   Tmin=2*290*A(6,1)*(K1+R1)/Ro
6555   S1=2*(A(1,1)*A(1,3)+A(1,2)*A(1,4))/Ro
6565   S2=2*(A(3,1)*A(3,3)+A(3,2)*A(3,4))*Ro
6575   T1=A(1,1)*A(3,3)+A(1,2)*A(3,4)+A(1,3)*A(3,1)+A(1,4)*A(3,2)
6585   T2=A(1,2)*A(3,3)-A(1,1)*A(3,4)+A(1,4)*A(3,1)-A(1,3)*A(3,2)
6595   Kf=S1*S2-T2^2
6605   Ks=1
6615   IF (Kf<0) OR (T1<0) THEN Ks=-1
6625   IF Ks>0 THEN 6645
6635   PRINT "K<1 Simultaneous match is not possible"
6636   GOTO 6675
6645   R2=SQR(S1+S2-T2^2)/S2
6655   X2=-T2/S2
6665   Gmax=1/(T1+SQR(S1*S2-T2^2))
6675   A=(S1+S2-2*K1*(T1-1)+2*X1*T2)^2-4*(S1*S2-(T1-1)^2-T2^2)*(1-K1^2-X1^2)
6685   D=(T1-1-K1*S2)^2+(T2+X1*S2)^2
6695   R3=((S2-S1-SQR(A))*(T1-1-K1*S2)-2*(K1*T2+X1*(T1-1))*(T2+X1*S2))/(2*D)
6705   X3=((S2-S1-SQR(A))*(T2+X1*S2)+2*(K1*T2+X1*(T1-1))*(T1-1-K1*S2))/(2*D)
6715   PRINT "Stage #";K;TAB(30);"Source L1=";Ls;TAB(60);"Source C1=";Cs
6725   Ga=2*R1/(S2*(R1^2+X1^2)+2*(R1*T1+X1*T2)+S1)
6735   PRINT TAB(10);"Minimum noise  Z=";DROUND(R1*Ro,6);DROUND(X1*Ro,6);
6745   PRINT "Tmin=";DROUND(Tmin,6);"Ga  =" ;DROUND(10*LGT(Ga),6)
6755   IF Ks<0 THEN 6795
6765   Ta=Tmin+290*A(6,1)*((R2-R1)^2+(X2-X1)^2)/(R2*Ro)
6775   PRINT TAB(10);"Maximum gain  Z=";DROUND(R2*Ro,6);DROUND(X2*Ro,6);
6785   PRINT "Ta  =" ;DROUND(Ta,6);"Gmax=" ;DROUND(10*LGT(Gmax),6)
6795   Ta=Tmin+290*A(6,1)*((R3-R1)^2+(X3-X1)^2)/(Ro*R3)
6805   Ga=2*R3/(S2*(R3^2+X3^2)+2*(R3*T1+X3*T2)+S1)
6815   PRINT TAB(10);"Min. N. Measure Z=";DROUND(R3*Ro,6);DROUND(X3*Ro,6);
6825   PRINT "Ta  =" ;DROUND(Ta,6);"Ga  =" ;DROUND(10*LGT(Ga),6)
6835   PRINT
```

```
        select the optimum source impedance desired, using K,R1,R2,
        t=R3
6865  Xopt=X3
6875  CALL Zio(A(*),Ropt*Ro,Xopt*Ro,0,0,0,0,R,X,1)
6885  CALL Gammaz(-1,C,D,Ropt*Ro,Xopt*Ro)
6895  Y(5*K-4)=Zo*SQR((1-C)/(1+C))
6905  W(5*K-4)=0.1am
6915  Y(5*K-3)=Zo
6925  W(5*K-3)=(1-D/180)*0.1am
6935  CALL Gammaz(-1,C,D,R,X)
6945  Y(5*K-2)=Zo
6955  W(5*K-2)=(1+D/180)*0.1am
6965  Y(5*K-1)=Zo*SQR((1-C)/(1+C))
6975  W(5*K-1)=0.1am
6985  IF K=N THEN 7035
6995  ! Insert here the physical length of the line between this stage
7005  ! and the next one
7015  INPUT "Trombone line following this stage ?",W(5*K)
7025  Y(5*K)=Zo
7035  NEXT K
7045  FOR K=1 TO 5*N-1
7055  PRINT "Line number";K;" Zo=";DROUND(Y(K),6),"Length=";DROUND(W(K),6)
7065  NEXT K
7075  FOR F=F1 TO F2 STEP Df
7085  FOR K=1 TO N
7095  Ls=L(K)
7105  Cs=Cap(K)
7115  GOSUB Circuit
7125  IF K=N THEN 7155
7135  CALL InLine(B(*),Y(5*K),W(5*K),1)
7145  CALL Cas(A(*),B(*))
7155  IF K=1 THEN 7185
7165  CALL Cas(C(*),A(*))
7175  GOTO 7195
7185  MAT C=A
7195  NEXT K
7205  CALL Saveckt(C(*),4,4,-1)
7215  CALL Nperformance(C(*),0,50,0,50,0,G,1)
7225  NEXT F
7235  GRAPHICS !GGGGGGGG
7245  SCALE F1,F2,-30,0
7255  C=4/236.2 !GHz/mm
7265  D=30/162.5 !dB/mm
7275  LINE TYPE 3
7285  AXES 1,2,Fo,-10
7295  AXES 1,10,Fo,-20
7305  LINE TYPE 5
7315  FOR K=1 TO Count
7325  PLOT Dat(K,1),10*LGT(Dat(K,2)^2+Dat(K,3)^2) !S11 is dot-dashed
7335  NEXT K
7345  PENUP
7355  LINE TYPE 3
7365  FOR K=1 TO Count
7375  PLOT Dat(K,1),Dat(K,14)/20-30 !noise is dashed
7385  NEXT K
7395  PENUP
7405  LINE TYPE 1
7415  FOR K=1 TO Count
7425  PLOT Dat(K,1),10*LGT(Dat(K,6)^2+Dat(K,7)^2)-30 !S21 is solid
7435  NEXT K
7445  PENUP
7455  LINE TYPE 7
7465  FOR K=1 TO Count
7475  PLOT Dat(K,1),10*LGT(Dat(K,8)^2+Dat(K,9)^2) !S22 is dble dot da
7485  NEXT K
7495  LOG 1
```

```
      =1
      LINE TYPE 1
7535 FOR F=F1 TO F2 STEP 2
7535   IF F<F2 THEN 7565
7545     G=-1
7555     LORG 7
7565     MOVE F+G*C,D-30
7575     LABEL USING "K";F
7585 NEXT F
7595 LDIR 90
7605 FOR G=-20 TO 0 STEP 10
7615   MOVE F2-C,G-D
7625   LABEL USING "K";G
7635   MOVE Fo-C,G-D
7645   LABEL USING "K";20*(G+30)
7655 NEXT G
7665 LORG 4
7675 MOVE F2-5*C,-15
7685 LABEL USING "K";"IRG"
7695 MOVE Fo-5*C,-15
7705 LABEL USING "K";"NOISE"
7715 LORG 6
7725 MOVE F1+5*C,-15
7735 LABEL USING "K";"GAIN"
7745 LORG 9
7755 FOR G=-20 TO 0 STEP 10
7765   MOVE F1+C,G-D
7775   LABEL USING "K";G+30
7785 NEXT G
7795 LDIR 0
7805 FRAME
7815 PAUSE
7825 GOTO 7235
7835 SUBEXIT
7845 Circuit: !
7855   GOSUB Fet
7865   CALL Trline(B(*),Y(5*K-3),W(5*K-3),1)
7875   CALL Cas(B(*),A(*))
7885   CALL Trline(A(*),Y(5*K-2),W(5*K-2),1)
7895   CALL Cas(B(*),A(*))
7905   CALL Trline(A(*),Y(5*K-4),W(5*K-4),1)
7915   CALL Cas(A(*),B(*))
7925   CALL Trline(B(*),Y(5*K-1),W(5*K-1),1)
7935   CALL Cas(A(*),B(*))
7945   RETURN
7955 Fet: ! NE-137 Model at 300K           01/27/82
7960 DISP "Analyzing the ckt model . . .   FREQ =";F
7965 CALL Rlc(A(*),"S",0,0,.036,"S",0)           !C2
7970 CALL Source(B(*),"V","C",45.6,1E7,400.9,1.28) !gm,R4,T
7975 CALL Par(B(*),A(*))
7980 CALL Rlc(A(*),"S",0,0,.270,"P",0)           !C1
7985 CALL Cas(A(*),B(*))
7990 CALL Rlc(B(*),"S",0,0,.132,"P",0)           !C3
7995 CALL Cas(A(*),B(*))
8000 CALL Rlc(B(*),"S",4.4,.106,0,"P",0)         !R2,L2
8005 CALL Ser(B(*),A(*))
8010 CALL Rlc(A(*),"S",6.99,.081,0,"S",0)        !R1,L1
8015 CALL Cas(A(*),B(*))
8020 CALL Rlc(B(*),"S",4,.090,0,"S",0)          !R3,L3
8025 CALL Cas(A(*),B(*))
8030 CALL Rlc(B(*),"S",0,0,.01,"P",0)           !C4
8035 CALL Cas(B(*),A(*))                         !NE 13700
8040 Tmin=182*F/15
8045 Ropt=6.64*15/F
8050 Xopt=27.33*15/F
8055 Gn=26.5*(F/15)^2
```



```
8060 CALL Nload(B(*),4,Tmin,Ropt,Xopt,Gn) !Noise model
8065 CALL Ric(A(*),"S",0,.350,0,"S",0) !Packaging L's
8070 CALL Cas(B(*),A(*))
8075 CALL Cas(A(*),B(*))
8076 CALL Ric(B(*),"S",0,0,.150,"P",0) !Packaging C's
8077 CALL Cas(A(*),B(*))
8078 CALL Cas(B(*),A(*))
8079 CALL Ric(A(*),"P",0,Ls,Cs,"P",0) !Source L-C
8080 CALL Ser(A(*),B(*))
8084 CALL Trline(B(*),120,.196,1) !Bias line
8085 CALL Ric(D(*),"P",50,0,1,"P",0)
8090 CALL Cas(B(*),D(*))
8095 CALL Branch(B(*),"P")
8100 CALL Cas(A(*),B(*))
8105 CALL Cas(B(*),A(*))
8135 CALL Trline(A(*),38,.085,1.8) !Output coupli
8140 CALL Branch(A(*),"S")
8145 CALL Cas(B(*),A(*))
8150 CALL Trline(A(*),38,.085,1.8) !Input couplin
8155 CALL Branch(A(*),"S")
8160 CALL Cas(A(*),B(*))
8165 DISP
8170 RETURN
8175 END
```

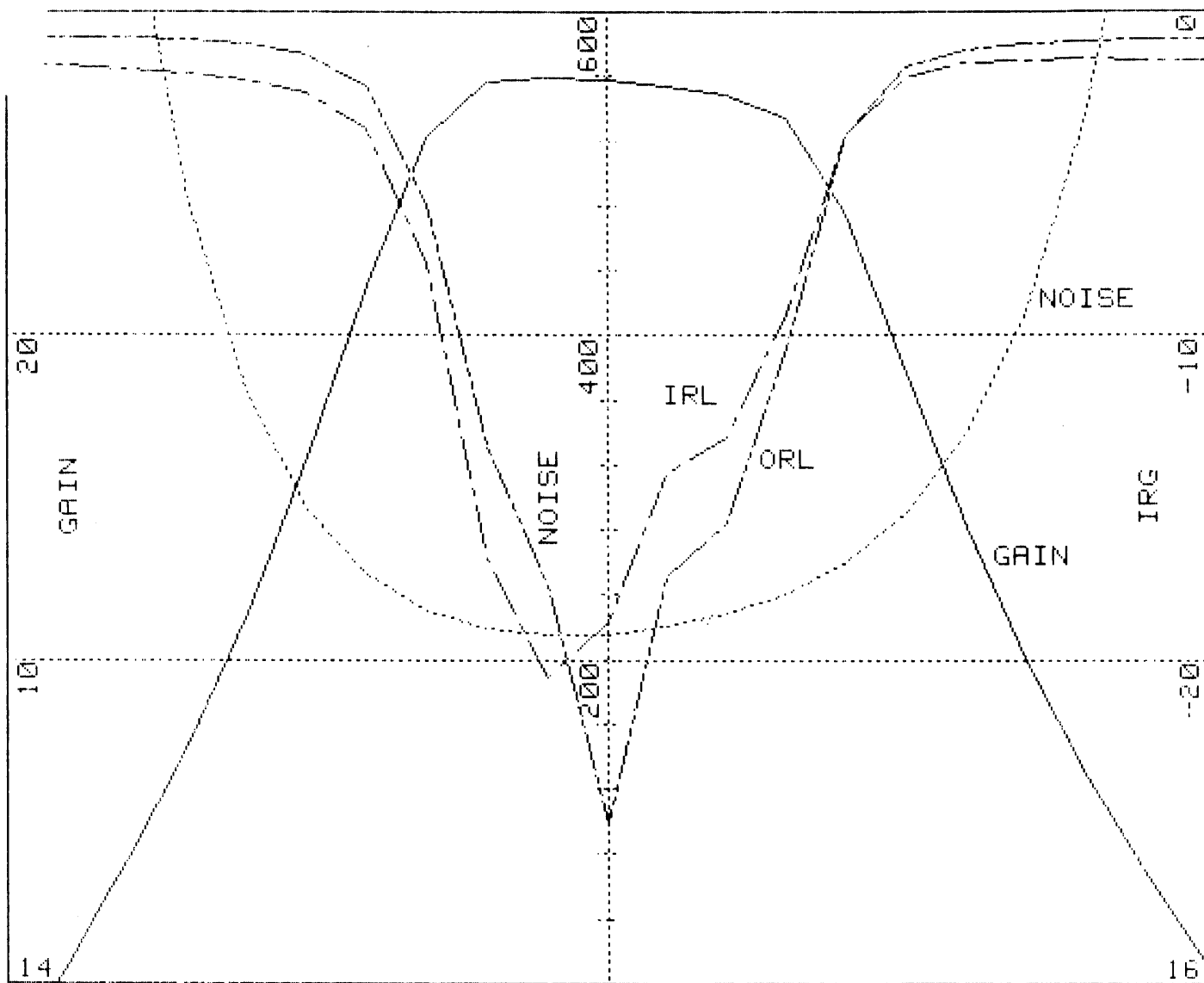
One to Three Stage Amplifier Analysis ("Amp #2")

The program allows the analysis of a one-, two- or three-stage amplifier with all the circuit parameters selected by the user.

It is possible to use it in two different modes by computing the frequency response (option = 0) or getting the spot center frequency response (option = 1) that allows a faster analysis and change in the circuit parameter.

Amp#2 as of 9/24/81

| Amp#2 as of 9/24/81 | | |
|-------------------------|---------|--------------|
| Source feedback FET # 1 | Ls= .03 | Cs= 0 |
| Source feedback FET # 2 | Ls= .03 | Cs= 0 |
| Source feedback FET # 3 | Ls= .03 | Cs= 0 |
| LINE # 1 | Zo= 18 | Lengh= .1967 |
| LINE # 2 | Zo= 50 | Lengh= .053 |
| LINE # 3 | Zo= 50 | Lengh= .092 |
| LINE # 4 | Zo= 12 | Lengh= .1967 |
| LINE # 5 | Zo= 50 | Lengh= .171 |
| LINE # 6 | Zo= 18 | Lengh= .196 |
| LINE # 7 | Zo= 50 | Lengh= .052 |
| LINE # 8 | Zo= 50 | Lengh= .092 |
| LINE # 9 | Zo= 12 | Lengh= .196 |
| LINE # 10 | Zo= 50 | Lengh= .171 |
| LINE # 11 | Zo= 18 | Lengh= .196 |
| LINE # 12 | Zo= 50 | Lengh= .052 |
| LINE # 13 | Zo= 50 | Lengh= .092 |
| LINE # 14 | Zo= 12 | Lengh= .196 |



```
      Cktanalysis(J(*),Fvalue,Opt)
      NT LIN(2);TAB(10);"Amp#2 as of 9/24/81"
      *ON BASE 1
6210 COM Nogo,Zo,F,Count,SHORT Dat(51,18)  ![[DAT] HOLDS FREQ, CKT
6215 DIM A(6,4),B(6,4),C(6,4),D(6,4),Y(15),W(15),L(3),Cap(3)
6220 STANDARD
6225 Count=Nogo=0          !#FREQS CURRENTLY STORED IN DATA BASE
6230 Zo=50
6235 DEG                   !DEFAULT FOR TRIG FUNCTIONS IS DEGR
6240 N=3
6241 Option=0
6245 Fo=15
6250 F1=14
6255 F2=16
6260 Nf=21
6265 Df=(F2-F1)/(Nf-1)
6270 DIM Fe(3,21,12)
6275 Qlam=11.8028527/(4*Fo)
6280 INPUT "Source L1 and C1 =",L(1),Cap(1)
6285 IF N=1 THEN 6305
6290 INPUT "Source L2 and C2 =",L(2),Cap(2)
6295 IF N=2 THEN 6305
6300 INPUT "Source L3 and C3 =",L(3),Cap(3)
6305 FOR I=1 TO Nf
6310   F=F1+(I-1)*Df
6315   FOR K=1 TO N
6320     Ls=L(K)
6325     Cs=Cap(K)
6330     GOSUB Fet
6335     CALL Ntrans(A(*),1)
6340     FOR J=1 TO 4
6345       Fe(K,I,J)=A(1,J)
6350       Fe(K,I,J+4)=A(3,J)
6355       Fe(K,I,J+8)=A(6,J)
6360     NEXT J
6365   NEXT K
6370 NEXT I
6375 RESTORE
6380 FOR K=1 TO 5*N-1
6385   READ Y(K),W(K)
6390 NEXT K
6395 W5=W(5)
6400 W10=W(10)
6405 Count=0
6410 W(5)=W5-W(3)-W(7)
6415 W(10)=W10-W(8)-W(12)
6425 IF Option=0 THEN 6435
6430 I1=INT((Nf+1)/2)
6435 FOR I=1 TO Nf
6440   IF Option=1 THEN I=I1
6445   F=F1+(I-1)*Df
6450   FOR K=1 TO N
6455     GOSUB Circuit
6460     IF K=H THEN 6475
6465     CALL Trline(B(*),Y(5*K),W(5*K),1)
6470     CALL Cas(A(*),B(*))
6475     IF K=1 THEN 6490
6480     CALL Cas(C(*),A(*))
6485     GOTO 6495
6490     MAT C=A
6495   NEXT K
6500   CALL Saveckt(C(*),4,4,-1)
6505   CALL Nperformance(C(*),3,50,0,50,0,G,1)
6510   IF Option=1 THEN I=Nf
6515 NEXT I
6520 IF Option=0 THEN 6560
```

```
        =10*LGT(Dat(1,2)^2+Dat(1,3)^2)
        =10*LGT(Dat(1,6)^2+Dat(1,7)^2)
6531  SLL=10*LGT(Dat(1,8)^2+Dat(1,9)^2)
6535  Tem=Dat(1,14)
6540  PRINT DROUND(S11,6);DROUND(S21,6);DROUND(S22,6);DROUND(Tem,4)
6541  PRINT W(2);W(3);W(5);W(7);W(8);W(10);W(12);W(13)
6545  INPUT "?",J1,J2
6546  IF J1=0 THEN Option=0
6547  IF J1=0 THEN 6405
6548  IF J1<0 THEN Y(ABS(J1))=J2
6550  IF J1>0 THEN W(J1)=W(J1)+J2
6555  GOTO 6405
6560  GRAPHICS
6565  SCALE F1,F2,-30,0
6570  C=4/236.2
6575  D=30/162.5
6580  LINE TYPE 3
6585  AXES 1,2,Fo,-10
6590  AXES 1,10,Fo,-20
6595  LINE TYPE 5
6600  FOR K=1 TO Count
6605  PLOT Dat(K,1),10*LGT(Dat(K,2)^2+Dat(K,3)^2)
6610  NEXT K
6615  PENUP
6620  LINE TYPE 3
6625  FOR K=1 TO Count
6630  PLOT Dat(K,1),(Dat(K,14)+300*((Dat(K,8)^2+Dat(K,9)^2)/10^(Dat(K,15)/10))
/20-30
6635  NEXT K
6640  PENUP
6645  LINE TYPE 1
6650  FOR K=1 TO Count
6655  PLOT Dat(K,1),10*LGT(Dat(K,6)^2+Dat(K,7)^2)-30
6660  NEXT K
6665  PENUP
6670  LINE TYPE 7
6675  FOR K=1 TO Count
6680  PLOT Dat(K,1),10*LGT(Dat(K,8)^2+Dat(K,9)^2)
6685  NEXT K
6690  LORG 1
6695  G=1
6700  LINE TYPE 1
6705  FOR F=F1 TO F2 STEP 2
6710  IF F<F2 THEN 6725
6715  G=-1
6720  LORG 7
6725  MOVE F+G*C,D-30
6730  LABEL USING "K";F
6735  NEXT F
6740  LDIR 90
6745  FOR G=-20 TO 0 STEP 10
6750  MOVE F2-C,G-D
6755  LABEL USING "K";G
6760  MOVE Fo-C,G-D
6765  LABEL USING "K";20*(G+30)
6770  NEXT G
6775  LORG 4
6780  MOVE F2-5*C,-15
6785  LABEL USING "K";"IRG"
6790  MOVE Fo-5*C,-15
6795  LABEL USING "K";"NOISE"
6800  LORG 6
6805  MOVE F1+5*C,-15
6810  LABEL USING "K";"GAIN"
6815  LORG 9
6820  FOR G=-20 TO 0 STEP 10
```

!GGGGGGGGGG

!GHz/mm
!dB/mm

!S11 is dot-dashed

!noise is dashed

!S21 is solid

!S22 is dble dot dash

```

      VE F1+C,G-D
      LABEL USING "K";G+30
6835 NEXT G
6840 LDIR 0
6845 FRAME
6850 PAUSE
6855 INPUT "Do you want to print this solution?",A#
6856 INPUT "Option =",Option
6860 IF A#="N" THEN 6900
6865 FOR K=1 TO N
6870 PRINT "Source feedback FET #";K,"Ls=";L(K),"Cs=";Cap(K)
6875 NEXT K
6880 FOR K=1 TO 5*N-1
6885 PRINT "LINE #";K,"Zo=";Y(K),"Lengh=";W(K)
6890 NEXT K
6895 PAUSE
6900 ! GCLEAR
6901 EXIT GRAPHICS
6902 IF Option=1 THEN 6405
6905 GOTO 6375
6910 SUBEXIT
6915 Circuit:
6920 FOR J=1 TO 4
6925 A(1,J)=Fe(K,I,J)
6930 J1=4*(J/2-INT(J/2))-1+J
6935 A(2,J1)=(-1)^J1*A(1,J)
6940 A(3,J)=Fe(K,I,J+4)
6945 A(4,J1)=(-1)^J1*A(3,J)
6950 A(6,J)=Fe(K,I,J+8)
6955 A(5,1)=A(5,2)=1
6960 NEXT J
6965 CALL Trline(B(*),Y(5*K-3),W(5*K-3),1)
6970 CALL Cas(B(*),A(*))
6975 CALL Trline(A(*),Y(5*K-2),W(5*K-2),1)
6980 CALL Cas(B(*),A(*))
6985 CALL Trline(A(*),Y(5*K-4),W(5*K-4),1)
6990 CALL Cas(A(*),B(*))
6995 CALL Trline(B(*),Y(5*K-1),W(5*K-1),1)
7000 CALL Cas(A(*),B(*))
7005 RETURN
7010 Fet: ! NE-137 Model at 300K 01/27/82
7015 DISP "Analyzing the ckt model . . . FREQ =";F
7020 CALL Rlc(A(*),"S",0,0,.036,"S",0) !C2
7025 CALL Source(B(*),"V","C",45.6,1E7,400.9,1.28) !gm,R4,T
7030 CALL Par(B(*),A(*))
7035 CALL Rlc(A(*),"S",0,0,.270,"P",0) !C1
7040 CALL Cas(A(*),B(*))
7045 CALL Rlc(B(*),"S",0,0,.132,"P",0) !C3
7050 CALL Cas(A(*),B(*))
7055 CALL Rlc(B(*),"S",4.4,.106,0,"P",0) !R2,L2
7060 CALL Ser(B(*),A(*))
7065 CALL Rlc(A(*),"S",6.99,.081,0,"S",0) !R1,L1
7070 CALL Cas(A(*),B(*))
7075 CALL Rlc(B(*),"S",4,.090,0,"S",0) !R3,L3
7080 CALL Cas(A(*),B(*))
7085 CALL Rlc(B(*),"S",0,0,.01,"P",0) !C4
7090 CALL Cas(B(*),A(*)) !NE 13700 in EB
7095 Tmin=182*F/15
7100 Ropt=6.64*15/F
7105 Xopt=27.33*15/F
7110 Gn=26.5*(F/15)^2
7115 CALL Nload(B(*),4,Tmin,Ropt,Xopt,Gn) !Noise model
7120 CALL Rlc(A(*),"S",0,.350,0,"S",0) !Packaging L's
7125 CALL Cas(B(*),A(*))
7130 CALL Cas(A(*),B(*))
7131 CALL Rlc(B(*),"S",0,0,.150,"P",0) !Packaging C'

```

```
7132 CALL Cas(A(*),B(*))
7133 CALL Cas(B(*),A(*))
7134 CALL Rlc(A(*),"P",0,Ls,Cs,"P",0) !Source L-C
7135 CALL Ser(A(*),B(*))
7139 CALL Trline(B(*),120,.196,1) !Bias line
7140 CALL Rlc(D(*),"P",50,0,1,"P",0)
7145 CALL Cas(B(*),D(*))
7150 CALL Branch(B(*),"P")
7155 CALL Cas(A(*),B(*))
7160 CALL Cas(B(*),A(*))
7190 CALL Trline(A(*),38,.085,1.8) !Output coupli
7195 CALL Branch(A(*),"S")
7200 CALL Cas(B(*),A(*))
7205 CALL Trline(A(*),38,.085,1.8) !Input couplin
7210 CALL Branch(A(*),"S")
7215 CALL Cas(A(*),B(*))
7220 DISP
7225 RETURN
7240 DATA 18,.1967 !Line # 1
7245 DATA 50,.0530 !Line # 2
7250 ! FET # 1
7255 DATA 50,.092 !Line # 3
7260 DATA 12,.1967 !Line # 4
7265 DATA 50,.315 !Line # 5 inter-stage
7270 DATA 18,.196 !Line # 6
7275 DATA 50,.052 !Line # 7
7280 ! FET # 2
7285 DATA 50,.092 !Line # 8
7290 DATA 12,.196 !Line # 9
7295 DATA 50,.315 !Line #10 inter-stage
7300 DATA 18,.196 !Line #11
7305 DATA 50,.052 !Line #12
7310 ! FET # 3
7315 DATA 50,.092 !Line #13
7320 DATA 12,.196 !Line #14
7325 SUBEND
```